



PICOCAP[®]

Preliminary Datasheet

PCapØ1Ax-0301

**Single-chip Solution for Capacitance Measurement
with Standard Firmware 03.01.02**

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1 System Overview

PCap01 is a dedicated Capacitance-to-Digital Conversion Digital Signal Processor. Its front end is based on acam's patented **PICOCAP®** principle. This conversion principle offers high resolution at conversion times as short as 2 μ s. Customers benefit from outstanding flexibility for optimizing power consumption, resolution and speed.

This datasheet describes PCap01A as it is used with the standard firmware 03.01xx. It can be used for grounded single and differential sensors as well as for floating single and differential sensors. With grounded capacitors the stray capacitance inside the chip will be compensated. With floating capacitors, the internal stray capacitance as well as the external stray capacitances get compensated. Additionally, the temperature can be measured by means of internal thermistors or external sensors. With firmware 03.01.xx PCap01A provides the pure capacitance and resistance ratios as data output without any further processing.

1.1 Features

- Digital measuring principle in CMOS technology
- Up to 8 capacitances in grounded mode
- Up to 4 capacitances in floating mode (potential-free and with zero bias voltage)
- Compensation of internal (grounded) and external parasitic capacities (floating)
- High resolution: up to
 - 6 aF at 5 Hz and 10 pF base capacitance
 - 17 bit resolution at 5 Hz with 100 pF base capacitance and 10 pF excitation
- High measurement rate: up to 500 kHz
- Extremely low current consumption possible: Down to 4 μ A at 3 Hz with 13.4 bit resolution
- High stability with temperature, low offset drift (down to 30 aF per Kelvin), low gain drift when all compensation options are activated.
- Dedicated ports for precision temperature measurement (with Pt1000 sensors, the resolution is 0.005 K)
- Serial peripheral interface (SPI compatible)
- Inter-Integrated Circuit Interface (I2C compatible)
- Self-boot capability
- Single power supply (2.1 to 3.6 V)
- No need for a clock
- RISC processor core using Harvard architecture:
 - 48 x 48 bit RAM Data
 - 4k x 8 bit volatile program memory for high-speed operation (40 to 100 MHz)
 - 4k x 8 bit non-volatile (OTP) program memory for normal speed operation (up to 40 MHz)

1.2 Applications

- Humidity sensors
- Position sensors
- Pressure sensors
- Force sensors
- Acceleration sensors
- Inclination sensors
- Tilt sensors
- Angle sensors
- Wireless applications
- Level sensors
- Microphones
- MEMS sensors

1.3 Block diagram

Figure 1-1: Block Diagram

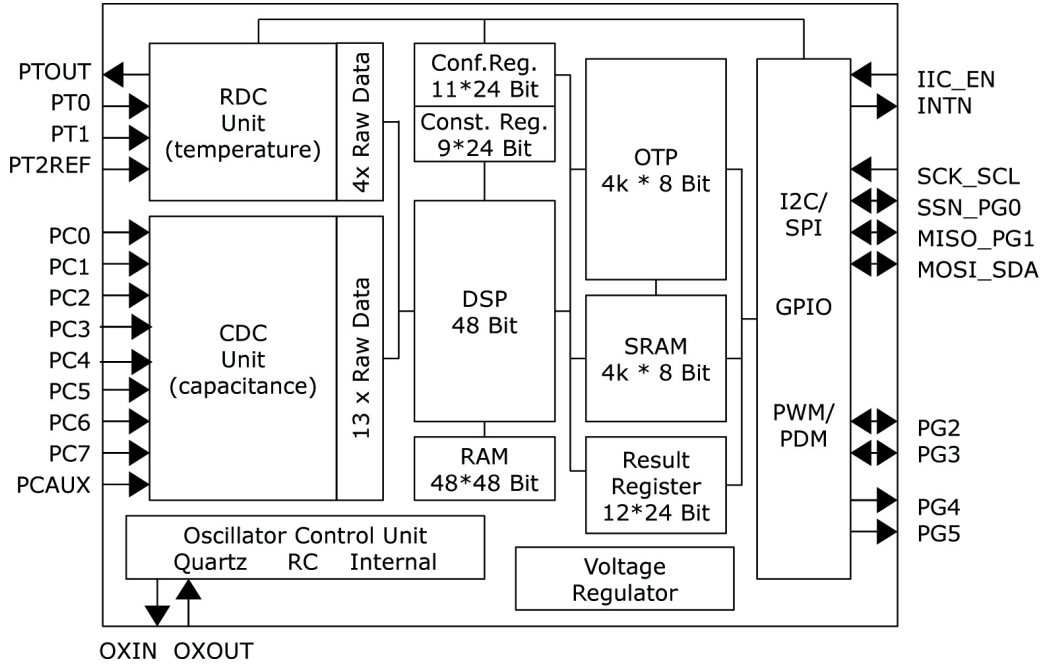


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2 Characteristics & Specifications

2.1 Electrical Characteristics

2.1.1 Absolute Maximum Ratings

Supply voltage V_{DD} -to-GND	- 0.3 to 4.0 V
Storage temperature T_{stg}	- 55 to 150 °C
ESD rating (HBM), each pin	> 2 kV
Junction temperature (T_j)	max. 125 °C
OTP Data Retention Period	10 years at 95 °C temperature

2.1.2 Recommended Operating Conditions

Table 2-1: Operating conditions

Quantity	Symbol	Remarks	Min.	Typ.	Max.	Unit
Supply voltage	V_{DD}		2.1		3.6	V
Digital port voltage	$V_{io_digital}$	Relative to ground	- 0.6	3.3	$V_{DD} + 0.6 \leq 3.6$	V
Digital ports switching level		HIGH → LOW LOW → HIGH		$0.3 * V_{DD}$ $0.7 * V_{DD}$		
Analog port voltage	V_{io_analog}		- 0.6		$V_{DD} + 0.6 \leq 3.6$	V
OTP Programming voltage	V_{OTP}	Between “VPP_OTP” port and ground. Do not expose other ports to programming voltage.		6.5	7.0	V
SPI bus frequency	f_{SPIbus}	Clock frequency for the 4-wire SPI bus operation	0		20	MHz
I2C bus frequency		Speed (data rate) of the 2-wire I2C bus operation	0		100 ⁽¹⁾	kHz
OTP Bit hold time		Bit hold time for OTP write	30		500	µs
GPIO input rise time		Rise time of the input signal put to general-purpose I/O			t.b.d.	ns
GPIO output rise time		Rise time of the output signal from a general-purpose I/O			t.b.d.	ns
CDC discharge time		MR1	0		40	µs
RDC discharge time			0		100	µs
Junction Temperature	T_j	Junction temperature must not exceed +125 °C	- 40		+ 125	°C
Ambient Temperature	T_a	At VDD = 2.4V -/+ 0.3V	- 40		+ 125	°C

⁽¹⁾ Overclocking is technically possible but within the sole responsibility of the customer [a license may be necessary].

2.2 CDC Precision

2.2.1 RMS Noise and Resolution vs. Output Data Rate

Table 2-2 Typical Capacitive Noise & Resolution vs. Output Data Rate, 10 pF Base + 1 pF Span, fast settle, V = 3.0 V

Output Data Rate [Hz]	FLOATING			GROUNDED		
	Fully compensated			Internally compensated		
	RMS Noise [aF]	Eff. Resolution 10 pF base [Bits]	Eff. Resolution 1 pF span [Bits]	RMS Noise [aF]	Eff. Resolution 10 pF base [Bits]	Eff. Resolution 1 pF span [Bits]
5	6	20.7	17.3	6	20.7	17.3
10	13	19.6	16.2	11	19.8	16.5
25	20	18.9	15.6	17	19.2	15.8
100	39	18.0	14.6	22	18.8	15.5
250	72	17.1	13.8	29	18.4	15.1
1,000	157	16.0	12.6	66	17.2	13.9
3,500	290	15.1	11.8	139	16.1	12.8
7,000	420	14.5	11.2	176	15.8	12.5
10,000	495	14.3	11.0	246	15.3	12.0

Table 2-3 Typical Capacitive Noise & Resolution vs. Output Data Rate, 33 pF Base + 3.3 pF Span, fast settle, V = 3.0 V

Output Data Rate [Hz]	FLOATING			GROUNDED		
	Fully compensated			Internally compensated		
	RMS Noise [aF]	Eff. Resolution 33 pF base [Bits]	Eff. Resolution 3.3 pF span [Bits]	RMS Noise [aF]	Eff. Resolution 33 pF base [Bits]	Eff. Resolution 3.3 pF span [Bits]
5	18	20.8	17.5	12	21.4	18.1
10	26	20.3	17.0	16	21.0	17.7
25	42	19.6	16.3	28	20.2	16.8
100	79	18.7	15.4	50	19.3	16.0
250	134	17.9	14.6	75	18.7	15.4
1,000	321	16.6	13.3	176	17.5	14.2
3,500	546	15.9	12.6	325	16.6	13.3
7,000	756	15.4	12.1	508	16.0	12.7
10,000	1119	14.8	11.5	742	15.4	12.1

Root mean-square (RMS) noise in aF as a function of output data rate in Hz, measured at 3.0 V supply voltage using the maximum possible sample size for in-chip averaging at the minimum possible cycle time. Bit values are calculated as a binary logarithm of noise (in attofarad) over the base and excitation capacitance values. The measurements have been done with the PCap01 evaluation board, with fixed COG ceramic capacitors.

Both, sensor and reference are connected “floating” or “grounded”, as indicated. When floating, compensation mechanisms for both internal and external stray capacities are activated, when grounded, internal ones only.

Table 2-4 Typical Capacitive Noise & Resolution vs. Output Data Rate, 100 pF Base + 10 pF Span, fast settle, V = 3.0 V

Output Data Rate [Hz]	FLOATING Fully compensated			GROUNDED Internally compensated		
	RMS Noise [aF]	Eff. Resolution 100 pF base [Bits]	Eff. Resolution 10 pF span [Bits]	RMS Noise [aF]	Eff. Resolution 100 pF base [Bits]	Eff. Resolution 10pF span [Bits]
	5	71	20.4	17.1	106	19.8
10	91	20.1	16.7	133	19.5	16.2
25	185	19.0	15.7	226	18.8	15.4
100	321	18.2	14.9	350	18.1	14.8
250	543	17.5	14.2	480	17.7	14.3
1,000	1044	16.5	13.2	987	16.6	13.3
3,500	3320	14.9	11.6	1965	15.6	12.3
7,000	4226	14.5	11.2	3675	14.7	11.4

Figure 2-1 Typical Capacitive Noise vs. Output Data Rate, with 10 pF Base Capacitance, V = 3.0 V

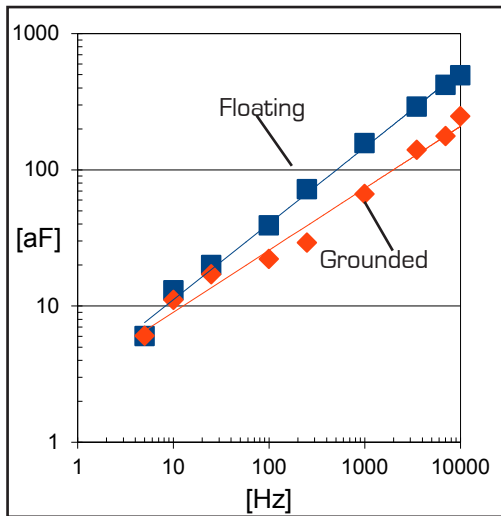


Figure 2-2 Typical Capacitive Noise vs. Output Data Rate, with 33 pF Base Capacitance, V = 3.0 V

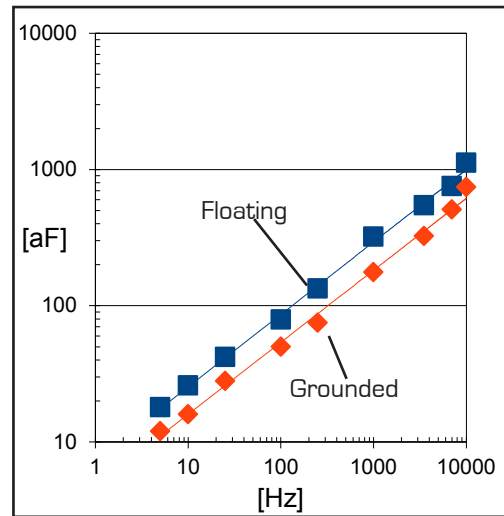
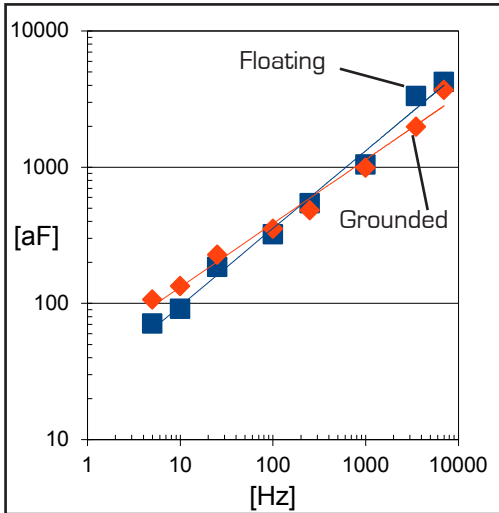
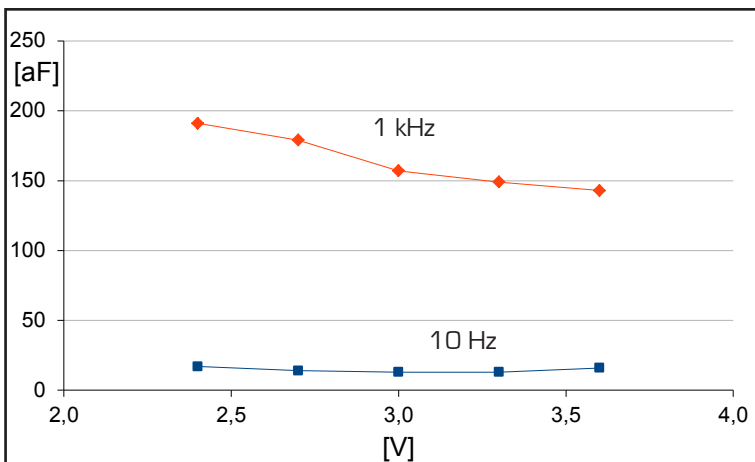


Figure 2-3 Typical Capacitive Noise vs. Output Data Rate, with 100 pF Base Capacitance, V = 3.0 V



2.2.2 RMS Noise vs. Supply Voltage

Figure 2-4 RMS Noise vs. Supply Voltage



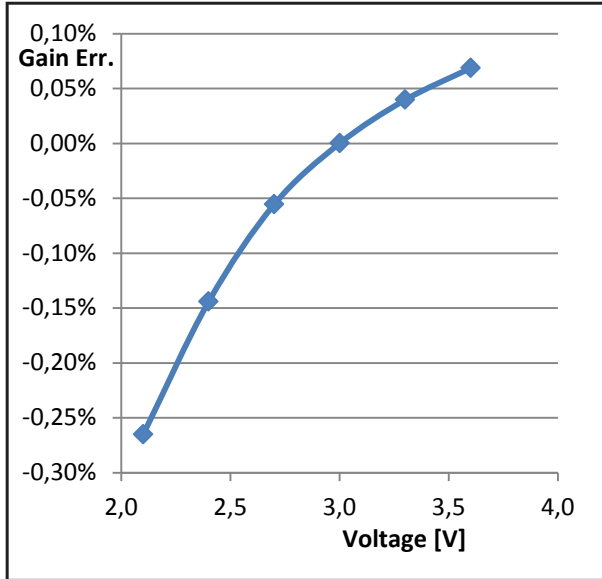
RMS Noise expressed in aF as a function of VDD power supply voltage.

The upper curve is for 1 kHz output data rate, the lower curve for 10 Hz.

Data acquired like before with 10 pF ceramic COG capacitors connected “floating” in place of reference and sensor. The excitation capacitor was a 1 pF ceramics COG type.

2.2.3 Voltage-Dependent Offset and Gain Error (PSRR)

Figure 2-5 Gain Error in % vs. Supply Voltage (Power Supply Rejection Ratio)



Data acquired like before with 100 pF ceramic COG capacitors connected “floating” in place of reference and sensor. The excitation capacitor was a 10 pF ceramics COG type.

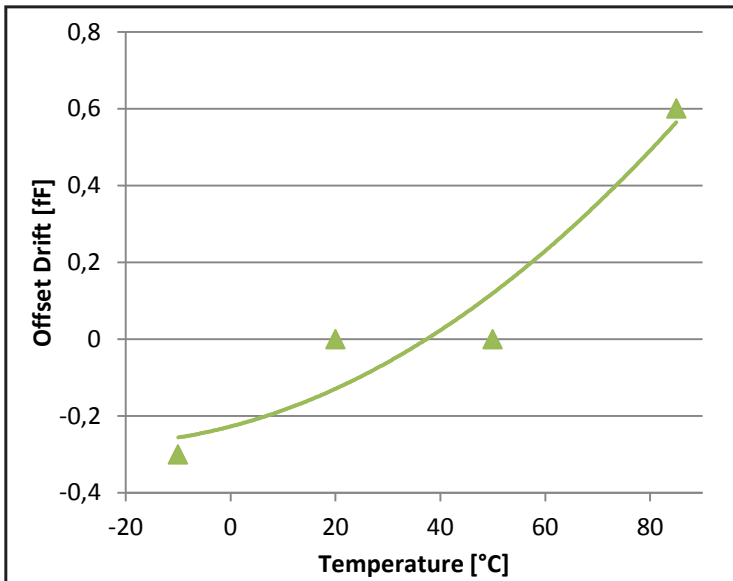
The gain drift is the principal contribution to the error; offset drift is negligible. No dependency on update rate has been detected.

At present, power-supply rejection ratio is poor, so the component needs well-filtered, stable supply voltages. Linear regulators will be indicated in most cases. The data presented here have been acquired in such conditions.

Any switching regulator in the supply line must be separated from the chip through a linear voltage regulator, combined with some purposefully designed RC filter. Any drift and noise in the supply line add error and noise to the output.

2.2.4 Temperature-Dependent Offset and Gain Error

Figure 2-5 Offset Drift vs. Temperature

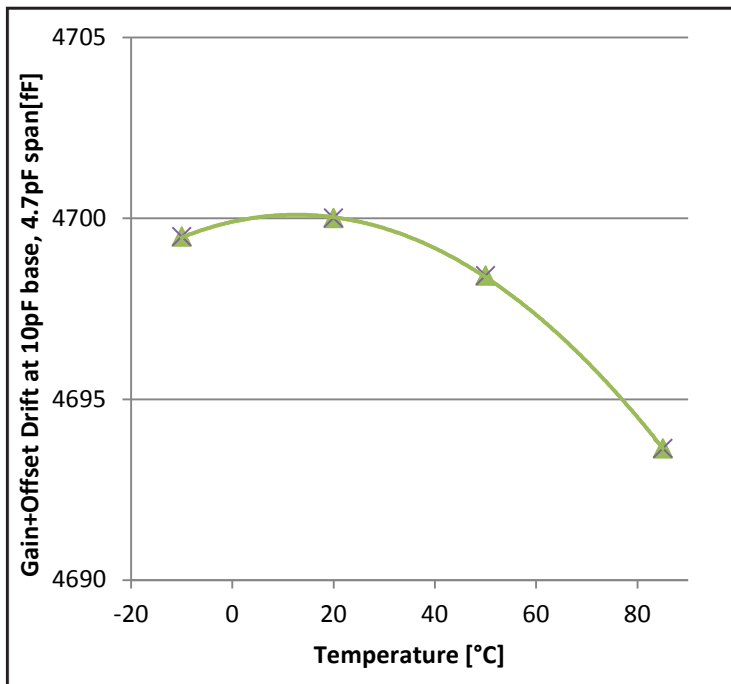


Offset drift as a function of temperature at 3.0V supply voltage VDD. 10 pF base capacitance, both sensor and reference, a COG ceramics capacitor each, connected “floating”.

Offset Drift:

3.0 V: 9.5 aF/K

Figure 2-6 Gain Drift vs. Temperature



Gain drift as a function of temperature at 3.0V supply voltage VDD. 10 pF base capacitance, both sensor and reference, plus 4.7 pF span, with COG ceramics capacitors each, connected “floating”.

Offset Drift:

3.0 V: 13 ppm/K

2.3 RDC Precision

Thermoresistive Coefficients T_k at 20 °C

Material	T_k
Internal polysilicon reference	-1.1 ppm/K
Internal aluminum thermistor	2830 ppm/K
External PT1000 sensor	3830 ppm/K

Resolution with internal Al/PolySi at 20 °C

Measurement Conditions	R2/Rref typ.	RMS noise	Typical RMS noise (*)
		R2/Rref	Temperature
No averaging, 2 fake measurements	0.825	50 ppm	25 mK
16-fold averaging, 8 fake measurements	0.823	10 ppm	5 mK

(*) after linearization in post-processing software

Typical Error with internal Al-thermometer after linearization and conversion into temperature, assuming a linear relation between temperature and resistivity:

-20 °C < Temp. < 0 °C 290 mK

0 °C < Temp. < 80 °C 110 mK

2.4 Power Consumption

Table 2-4 Total Current I [μ A] as a function of speed [SEQTIME] and resolution [C_AVRG] in Triggered Mode

SEQTIME (data rate [Hz])		I [μ A]								
		C_AVRG (RMS resolution [Bits])								
		1 (11.3)	4 (12.3)	16 (13.4)	64 (14.4)	128 (14.9)	256 (15.4)	512 (15.9)	1024 (16.4)	2048 (16.9)
13	(3.1)	4	4	4	5	10	10	55	80	150
12	(6.1)	4	5	7	10	20	35	80	150	
11	(12.2)	5	6	9	22	40	80	160		
10	(24.4)	6	8	15	44	82	160			
9	(48.8)	8	12	27	85	160				
8	(97.7)	12	20	49	163					
7	(195.0)	20	35	93						
6	(391.0)	36	65	178						
5	(781.0)	67	124							
4	(1560.0)	127	236							
3	(3120.0)	229								
2	(6250.0)	409								

Table 2-4 Total Current I [μ A] as a function of speed [SEQTIME] and resolution [C_AVRG] in Continuous Mode
(This mode yields highest possible speed/performance)

	C_AVRG (RMS resolution [Bits])								
	1 (11.3)	4 (12.3)	16 (13.4)	64 (14.4)	128 (14.9)	256 (15.4)	512 (15.9)	1024 (16.4)	2048 (16.9)
I [μ A]	515	275	204	185	182	181	180	180	179

Temperature measurement in addition to capacitive measurement will add between 2 and 10 μ A approximately, depending on speed. Total consumption values below 30 μ A may be obtained only when driving the on-chip 1.8 volts core supply generator in an energy-saving mode (see section 5, register 10); ultimate microamp savings with DSP slowed down (see section 5, register 8).

2.5 Package Information

2.5.1 Dice - Pad Layout

Die dimensions: 2.15 mm x 1.67 mm with pad pitch 120 µm, pad opening is 85 µm x 85 µm

2.5.2 QFN Packages

Figure 2-7: QFN package dimensions

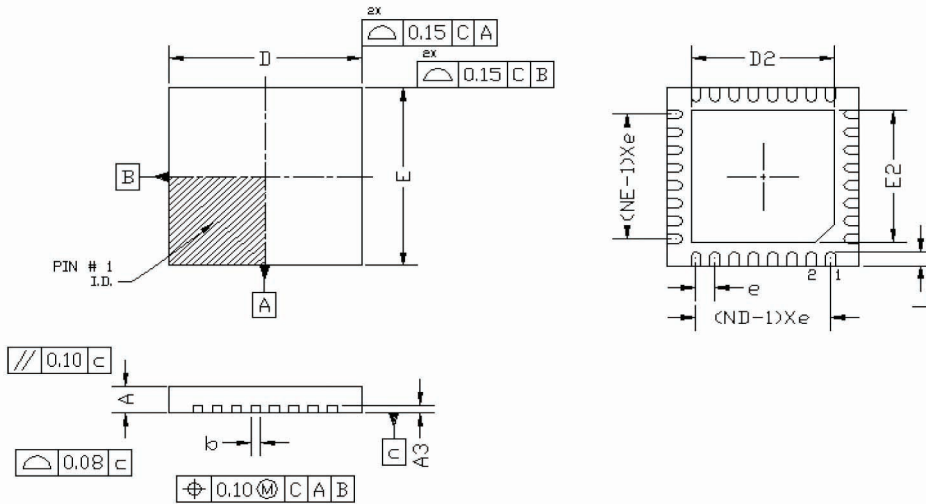


Table 2-5: QFN Dimensions

Device Name	Package	Dimensions in mm							
		D, E	D2, E2	N	e	L	b	A	A3
PCap01-AD	QFN32	5.00	2.70	8	0.5	0.4	0.25	0.75/0.9	0.20
PCap01-AK	QFN24	4.00	2.70	6	0.5	0.35	0.25	0.75/0.9	0.20

Dimensioning and tolerances acc. to ASME Y14.5M-1994

IMPORTANT NOTE: the dimensions above are true for mass production. During the prototype phase („prototype“ with respect to the device not to your application), other values apply, please consult.

2.5.3 Pin-Out QFN32 and QFN24 Versions

Figure 2-8

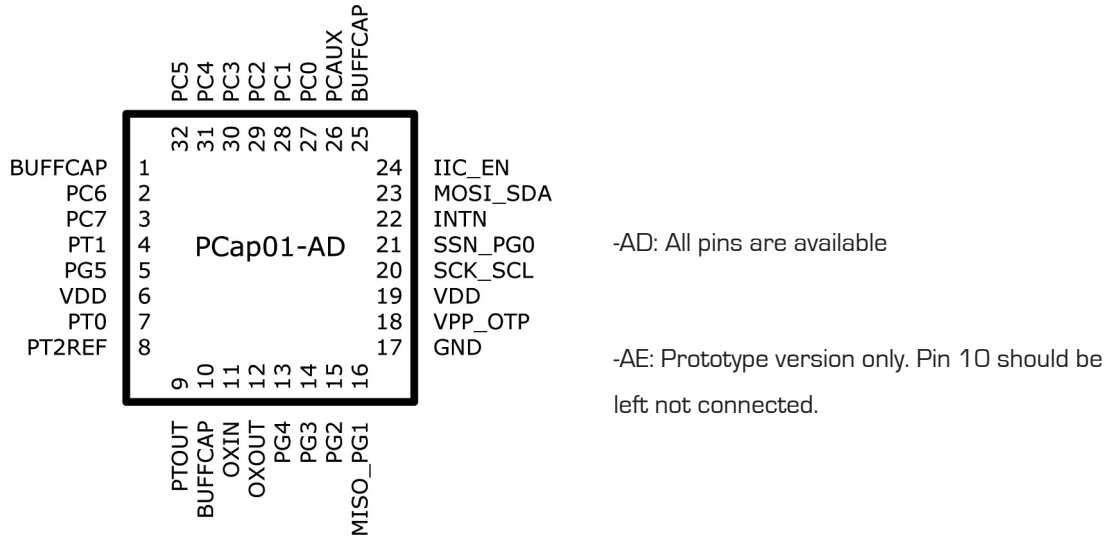
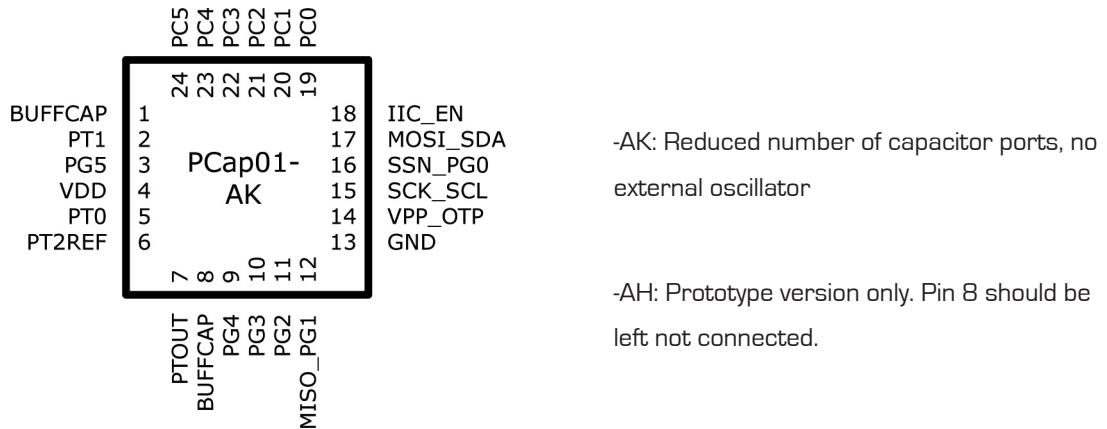


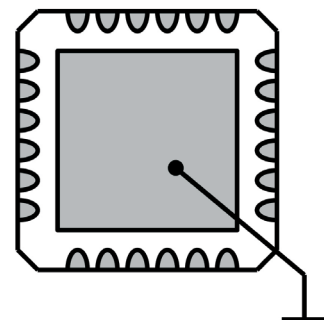
Figure 2-9



QFN packages provide a large square bottom pad, often called “thermal pad”. This pad carries ground potential to the device.

Figure 2-10 QFN Ground Pad

Connecting it to ground is mandatory. A multiple-via heat conduction path is not required in most cases, because this IC device produces very little heat. The situation may be different, though, in those applications where the on-chip thermometer is to be used.



2.5.4 Pin/Pad Assign

Pin	Description	Comment	Pin Number		
			-AD	-AK	
BUFFCAP	Connect microfarad bypass capacitance and nanofarad bypass capacitance to GND. Bridge pins 1 and 25 if existing. Bypassing is mandatory!	Need to be connected in any case	1	1	
			10		
			25	8	
GND	Ground			17	13
IIC_EN	Put this to LOW or GND for use of SPI bus. Put it to HIGH or VDD otherwise.			24	18
INTN	Optional. Interrupt line, low active			22	
MISO_PG1	Serial interface data line, Master In - Slave Out (SPI only, otherwise available as general-purpose port)			16	12
MOSI_SDA	Serial interface data line, Master Out - Slave In			23	17
OXIN	May be left open. Very exceptionally used for connecting a 4 to 20 MHz ceramics resonator or quartz.			11	
OXOUT				12	
PC0	"CDC" or capacitive measurement ports. Connect reference and sensors here, beginning with PCØ for the reference.			27	19
PC1				28	20
PC2				29	21
PC3				30	22
PC4				31	23
PC5				32	24
PC6				2	
PC7				3	
PCAUX	May be used for external discharge resistor.		26		
PG2	General purpose I/O ports. PG4 and PG5 are outputs only, others are either input or output (configurable).		15	11	
PG3			14	10	
PG4			13	9	
PG5			5	3	
PT0	"RDC" or temperature measurement ports. Connect one side of the external resistive sensors here.		7	5	
PT1			4	2	
PT2REF	When there is an external resistive (temperature measurement) reference, connect it here, otherwise this is the place for a third resistive sensor.		8	6	
		Leave unconnected if not used			

PTOUT	Connect the other side of the resistive sensors and a 33 nF COG for temperature measurement here.	Leave unconnected if not used	9	7
SCK_SCL	Serial interface clock line		20	15
SSN_PGO	SPI interface chip select line, low active. Alternatively general purpose I/O port.		21	16
VDD	VDD here, plus bypass capacitance to GND. Bypassing is mandatory!	Connect to GND	6	4
VPP_OTP	Set to 6.5 V during OTP programming. Set back to GND rapidly after the end of the programming process. Keep pin grounded for normal device operation. Apply a 470 kOhm pull-down resistor to this pin.		18	14

-AE: Prototype version only, to be replaced by -AD. Pin 10 should not be connected.

-AH: Prototype version only, to be replaced by -AK. Pin 8 should not be connected.

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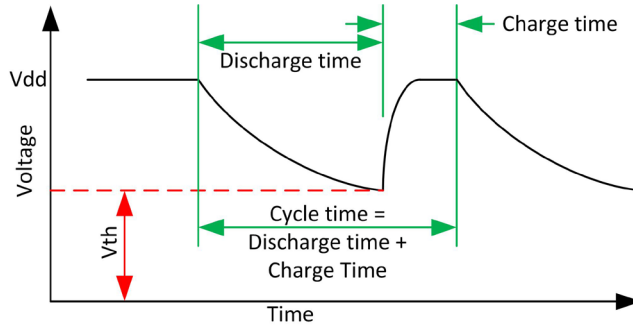
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3 Converter Frontend

3.1 CDC Measuring Principle

The device uses “discharge time measurement” as a principle for measuring either capacitance (the CDC unit) or resistivity (the RDC unit). It addresses all ports (PC...,PT...) in time multiplex.

Figure 3-1 Cycle Time



3.2 Important CDC Parameters

An important notion is “cycle time”, the period of one elementary discharge-and-recharge cycle, see figure 3-1.

The discharge time is given by the capacitors and the discharge resistor. The cycle time is the time interval between two discharge time measurements and is set by the user. The relevant parameter is CMEAS_CYTIME in register 4. The user has to take care that the charge time and therefore the cycle time is long enough. As default we recommend to have the cycle time > 2 x discharge time. Otherwise, the capacitors do not get charged sufficiently. Further, if the cycle time is less than the discharge time the CDC will show a time-out.

Measurement results are deduced as follows; discharge time ratios equal sensor-to-reference values:

$$\frac{\tau_N}{\tau_{ref}} = \frac{C_N}{C_{ref}}$$

This equation holds for the CDC, and is similar for the RDC.

Figure 3-2 Charging-/ discharging cycles grounded, compensated, single or differential sensors

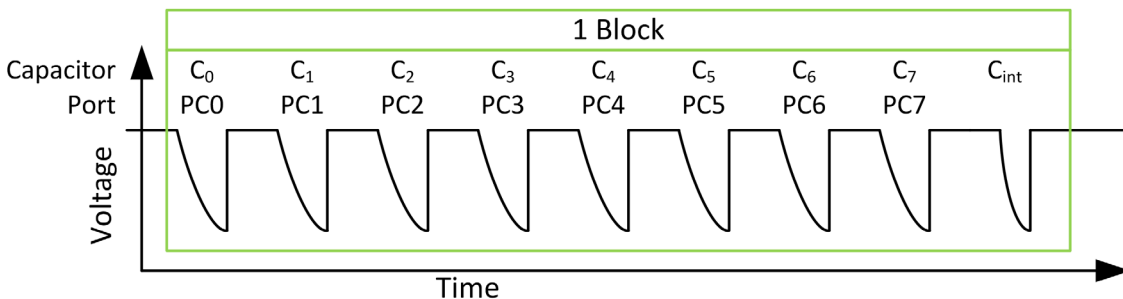


Figure 3-2 shows a CDC example with 7 single / 3 differential grounded sensors plus one reference. One measurement block is made of a discharge time measurement for each capacitor and an additional one for measuring the internal stray capacities and comparator delay [internal compensation].

Figure 3-3 Charging-/ discharging cycles floating, compensated, single and differential sensors

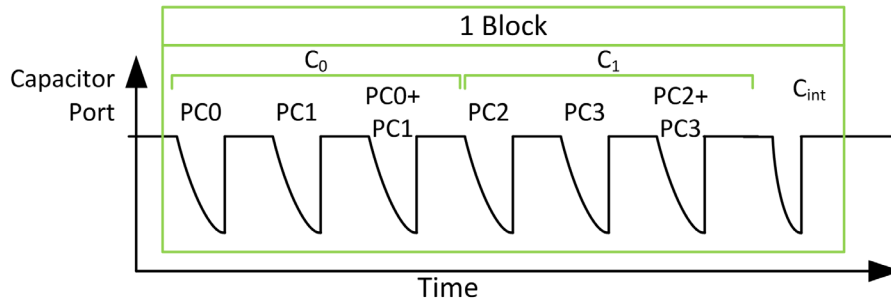
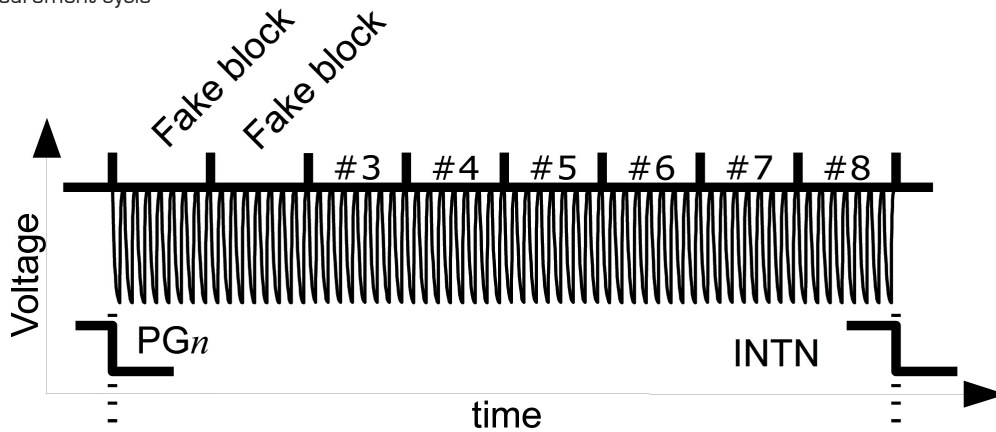


Figure 3-3 shows a CDC example with one floating single sensor plus reference / one floating differential sensor. One measurement block is made of 3 discharge time measurements for each capacitor, including the external compensation measurement, and an additional one for measuring the internal stray capacities and comparator delay. See section 3.6 for further details on the compensation.

Measurement rate or “output data rate” is inversely proportional to the cycle time and to the sum of “fake block number” and “averaging sample size”. If neither fake blocks nor on-chip averaging are requested, results will be updated after every “block”.

Figure 3-4 Measurement cycle



Example 1:

2 single grounded sensors + reference, cycle time = 20 μ s: block period = 80 μ s
 2 fake blocks + 4-fold averaging: measurement period = 480 μ s
 Maximum update rate = 2,083 Hz

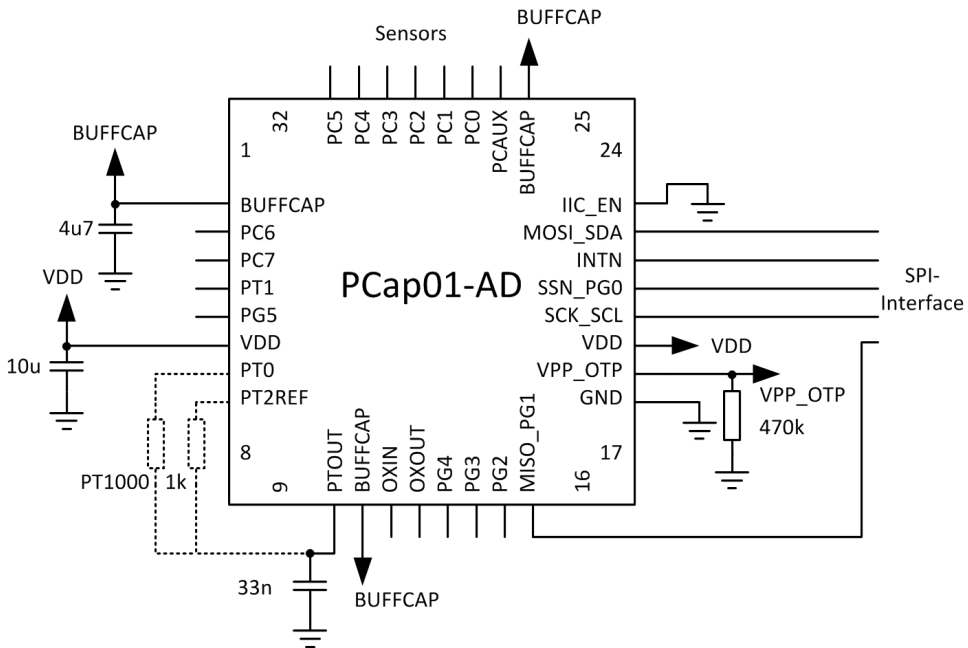
Example 2:

1 single floating sensor + reference, cycle time = 20 μ s: block period = 140 μ s
 2 fake blocks + 8-fold averaging: measurement period = 1400 μ s
 Maximum update rate = 714 Hz

3.3 CDC External Circuitry

Figure 3-5 shows the part of the schematic that is independent from capacitive sensor configuration. Here an example with the SPI interface used.

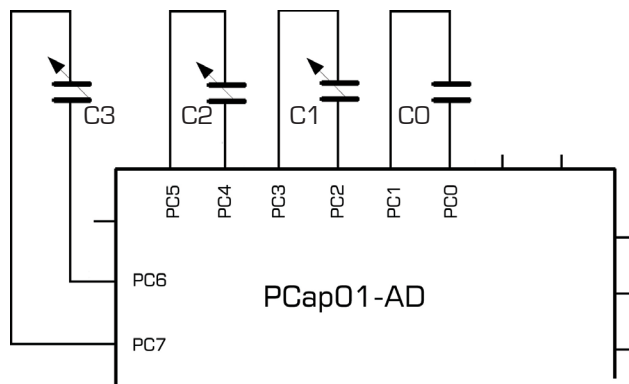
Figure 3-5: Schematics with sensors not shown¹



3.4 Connecting the Capacitive Sensors

The capacitive-sensor part of the schematic: Whenever possible, connect the sensors floating, not referenced to ground.

Figure 3-6: Single sensors, floating, up to 3 sensors and one reference



¹ Remark: Bypass capacitors should be ceramics type. Low noise operation is conditioned by a good bypassing. Place bypass close to the pins.

Figure 3-7: Single sensors, grounded, up to 7 sensors and one reference

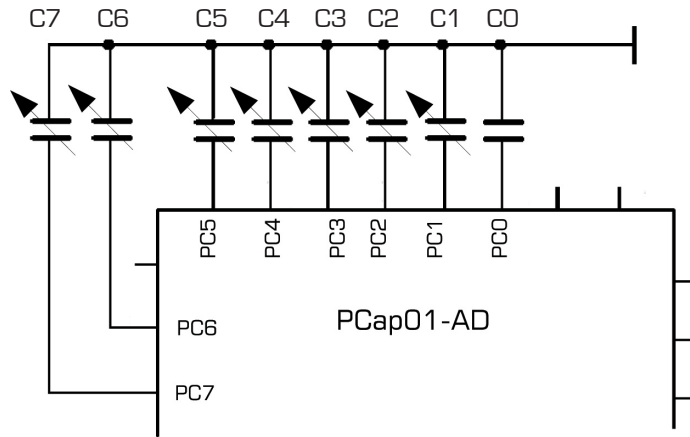


Figure 3-8: Differential sensors, floating

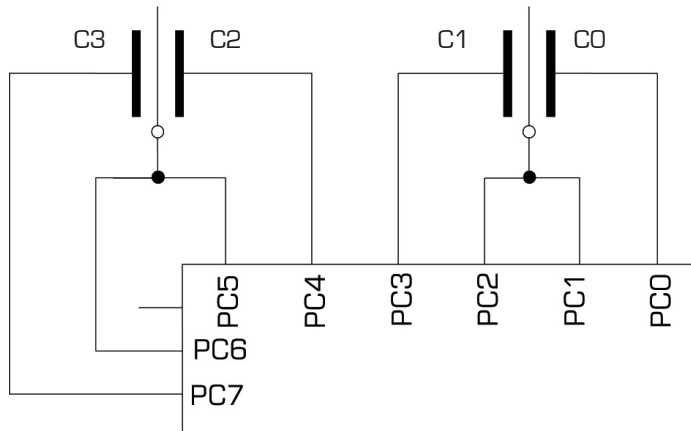
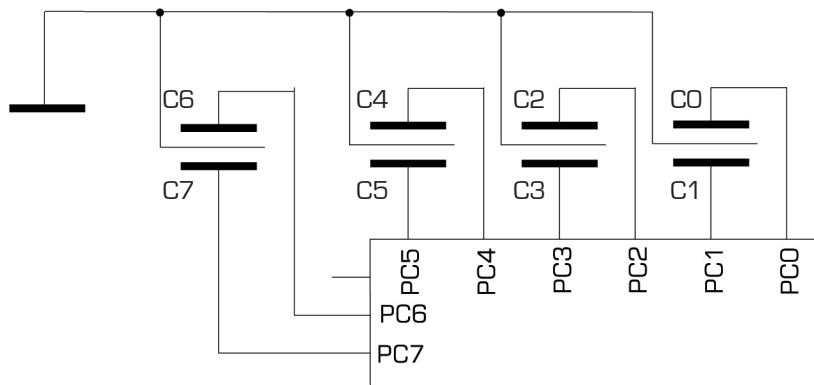


Figure 3-9: Differential sensors, grounded

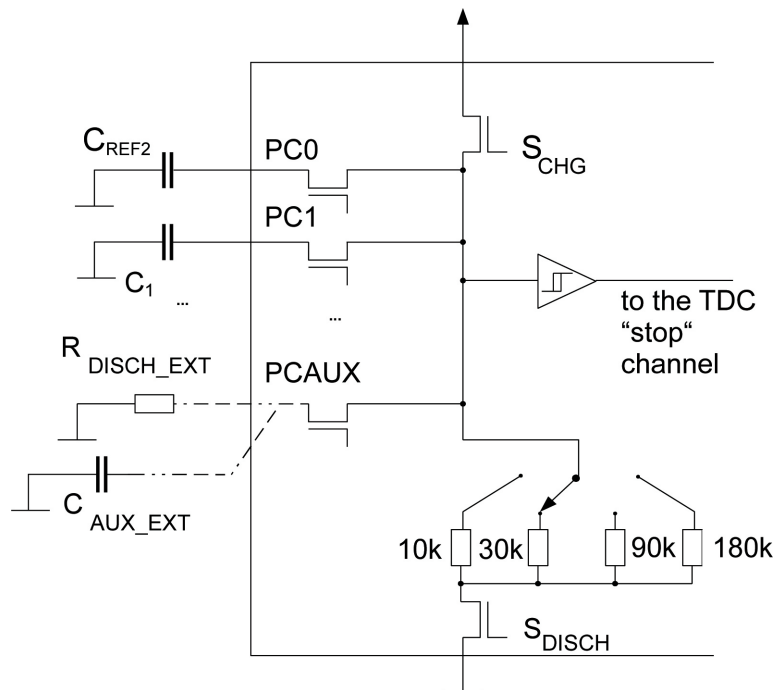
Set parameter CScheme=0.



3.5 Selecting the Discharge Resistor

The measurement is based on controlled discharging; within the CDC part, four selectable discharge resistivities down to 10 kOhms in size are available (see figure 3-10). They are useful for base capacitances from zero up to 3.5 nF. Not described in this short manual is the possibility of extending the measuring range to even higher capacitance values by connecting a small resistivity outside the chip.

Figure 3-10: CDC Dimensioning



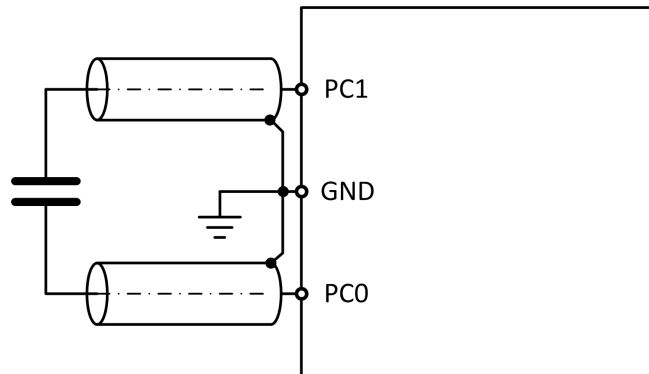
3.6 Compensation Measurement

With grounded capacitors the PCap01 offers the possibility to compensate for internal parasitic capacities and, having the same effect, the propagation delay of the comparator.

With floating capacitors we have the additional option to compensate the external parasitic capacities against ground. On the pcb the wire capacitance typically refers to ground. For long wires it is necessary to have shielded wires with the shields grounded on the pcb connection side.

Figure 3-11 shows how shielded cables shall be connected for compensation of the external parasitic capacities.

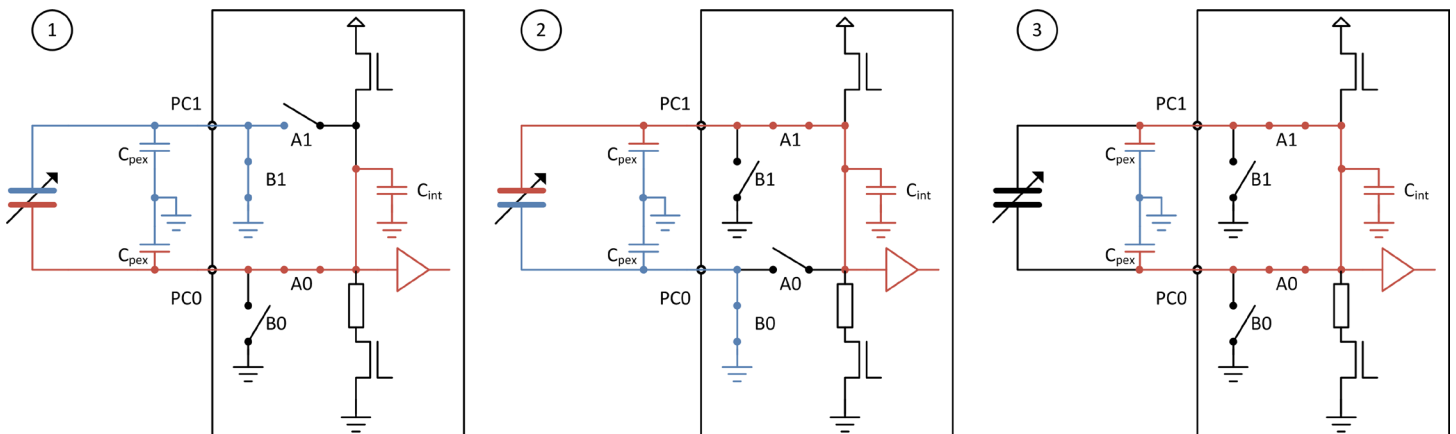
Figure 3-11 Connecting sensor by shielded cables



The three measurements necessary for each capacitor in case of floating sensors are shown in figure 3-12

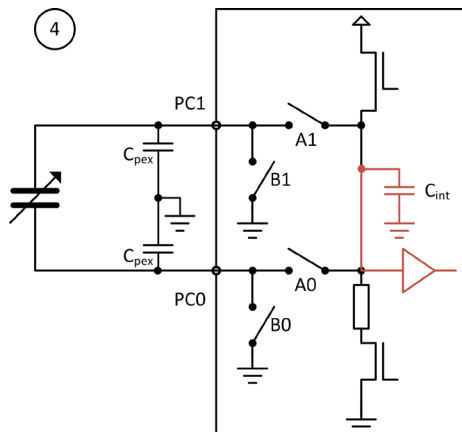
the three measurements that are made for each floating capacitor.

Figure 3-12 Floating capacitors, external compensation measurements



For the internal compensation measurement both switches A1 and A0 are open. Only the internal parasitic capacitance and the comparator propagation delay will be measured.

Figure 3-13 Grounded/floating capacitors, internal compensation measurement



3.7 RDC Temperature Measurement

The chip device has two on-chip resistor elements for the measurement of temperature, an aluminum strip with $TK \approx 2800 \text{ ppm/K}$ as a sensor and a polysilicon resistor with TK “close” to zero as a reference.

As an alternative, it is possible to connect the temperature sensor and reference resistor externally. [In general the chip may support two external sensors, but this option is not supported by this firmware version].

In any case, it is mandatory to connect an external 33 nF COG capacitor as the the temperature measurement is also done by discharge time measurements. COG material is recommended for good performance. X7R should not be used.

In principle, external and internal thermometers/reference may be mixed. E.g. an external PT1000 maybe compared to the internal Poly-Si resistor.

The selection between internal and external resistors is done by parameter TMEAS_7BITS in register 6:

A) External solution

Configuration:

Register 4 = 'h XX XX 01 (CMEAS triggered)

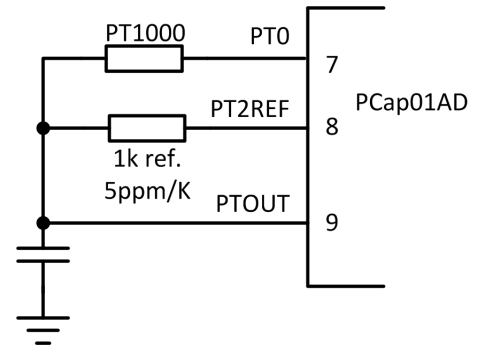
Register 5 = 'h CX XX XX

Register 6 = 'h 00 0C 40 (external resistors)

Output data:

Ratio PT1000/Rref as R0/Rref in read register Res10 (address 13).

Figure 3-14 RDC with external resistors



B) Completely internal solution

Configuration:

Register 4 = 'h XX XX 01 (CMEAS triggered)

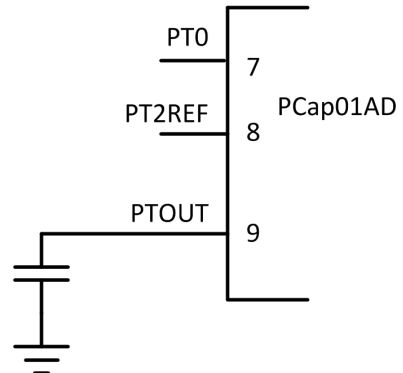
Register 5 = 'h CX XX XX

Register 6 = 'h 00 43 40 (external resistors)

Output data:

Ratio R[Al]/R[Si_poly] as R2/Rref in read register Res11 (address 14).

Figure 3-15 RDC with internal resistors



There are various trigger sources for the temperature measurement, set in register 4 by parameter TMEAS_TRIG_SEL. We strongly recommend to use TMEAS_TRIG_SEL = 1, trigger by capacitance measurement. With this setting, the temperature measurement follows directly each Nth capacitance measurement, where N is set by parameter TMEAS_TRIG_PREDIV in register 5. With TMEAS_TRIG_PREDIV = 0 the temperature measurement is done with each capacitance measurement. With TMEAS_TRIG_SEL = 0 the temperature measurement is triggered by software, sending opcode 'h8E. If no opcode is sent the temperature measurement is switched off.

For low power applications, it is recommended to set the divider TMEAS_TRIG_PREDIV to such a value that the temperature measurement is done maximum 10 times per second.

Figure 3-16 Temperature Measurement triggered by Capacitance Measurement (continuous mode)

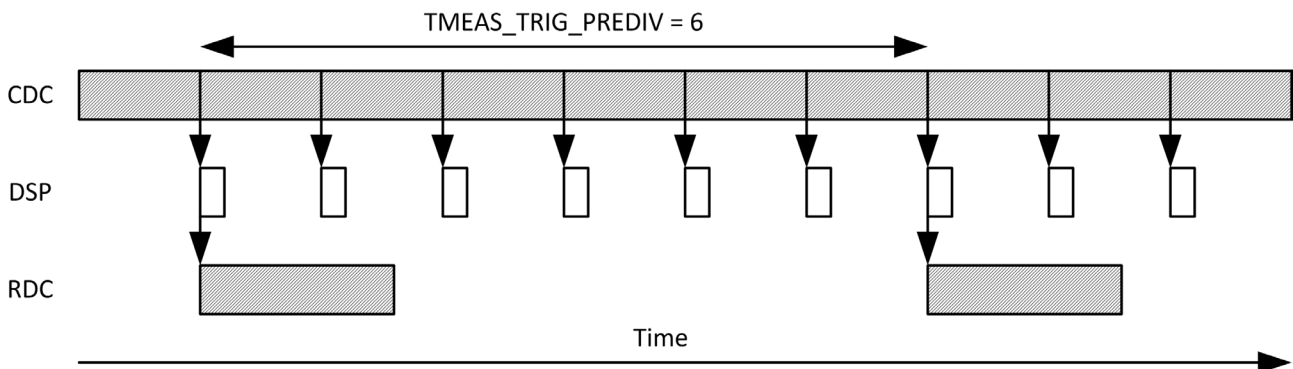
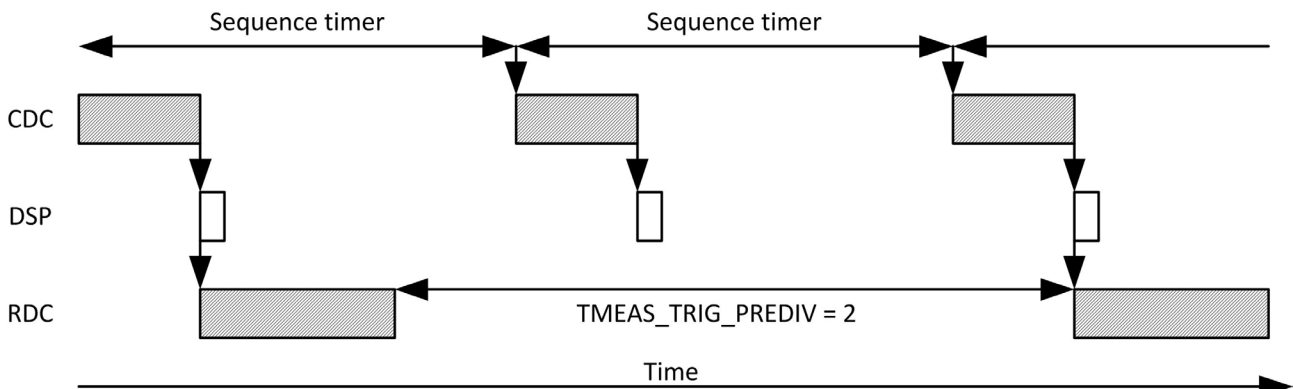


Figure 3-17 Temperature Measurement triggered by Capacitance Measurement (Sequence timer triggered)



Be aware that the resistivity measurement is based on an AC, not a DC method. So, cable between sensor and chip may contribute shift and noise through its inductance and capacitance. Twisted shielded cable may be a good choice, in some cases an active shield may help.

Issue a start command (op code 0x8C) and begin polling data or watching INTN. See section 6.5? for details. What you read is $R0/Rref$ or $R2/Rref$, the ratio between two resistivities.

External or internal sensors - you will need to calibrate either solution in a climate chamber.

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4	Interfaces (Serial And Pulse-Density)	4-2
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4.1.1	Op codes	4-2
4.1.2	I²C Compatible Interface	4-3
4.1.3	The 4-wire, SPI interface	4-4
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4 Interfaces (Serial And Pulse-Density)

4.1 Serial Interfaces

For operation with a micro-controller, and also for programming the device, two serial interfaces are available. Only one interface is available at a time, selected through the voltage applied to the pin "IIC_EN". Both interfaces are limited to "slave" rank, and both permit programming :

Pin IIC_EN is connected to GROUND	The 4-wire SPI interface is active. General-purpose I/O pins #0 and #1 are not available (occupied by SPI).
Pin IIC_EN is connected to VDD	The 2-wire I2C interface is active and all general-purpose I/O pins are available, including #0 and #1.

Remarks: The general-purpose I/O pins #2 through #5 are available in either case. If no controller interface is needed, put IIC_EN to VDD, not to ground. You must not leave this pin open.

Once programmed, the device can operate stand-alone. As both interfaces are limited to slave rank, stand-alone operation with data transfer to an ancillary device (e.g. an LCD converter or a D/A converter) will necessitate software implementation of a serial protocol (contact ACAM for details).

4.1.1 Op codes

Table 4-3: 8-Bit Op Code Commands

'h88	Power-up reset. This command resets everything.
'h8A	"Initial" or "partial" reset, leaves the SRAM contents and registers unchanged. Resets important parts of the device like the front-end and DSP
'h8C	Start a capacitance measurement sequence
'h84	Terminate the write-to-OTP process
'h8E	Start temperature measurement

Table 4-4: 24-Bit Op Code Commands

Command	Byte 2				Byte 1	Byte 0
Write to SRAM	1	0	0	1	Address<11...0>	Data<7...0>
Read SRAM	0	0	0	1	Address<11...0>	Data<7...0>
Write to OTP	1	0	1		Address<12...0>	Data<7...0>
Read OTP	0	0	1		Address<12...0>	Data<7...0>

Table 4-5: 32-Bit Op Code Commands

Command	Byte 3			Byte 2	Byte 1	Byte 0
Write Config	1	1		Cf_Address<5...0>	Registry Parameter<23...0>	
Read Results	0	1		Rs_Address<5...0>	Measurement Results<23...0> or Measurement Results<47...24>	

For Cf_Address, take the register cell number, 0 through 20 (decimal), see Register Map below.

As an Rs_Address, take one out of the range 0 to 14 (see also section 5.3).

4.1.2 I²C Compatible Interface

The present paragraph outlines the PCap01 device specific use of the I²C interface. For a general description of ACAM's subset of the I²C interface see the dedicated data sheet. See also the PCap01 bug report at the end of the present sheet.

The master begins the communication by sending a start condition, falling edge on the SDA line while SCL is HIGH. It stops the communication by a stop condition, a rising edge on the SDA line while SCL is high. Data bits are transferred with the rising edge of SCL.

On I²C buses, every slave holds an individual 7-bit device address, The address always has to be sent as the first byte after the start condition, the last bit indicating the direction of the following data transfer.

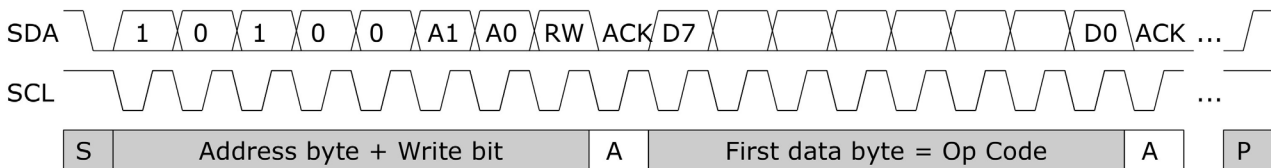
Address byte:

MSB							LSB
1	0	1	0	0	A1	A0	R/W
fixed					variable		

Default address: A1 = A0 = 0

The address is followed by the opcode and eventually the payload. Each byte is followed by an acknowledge bit (= 0). PCap01 has 8 bit, 24 bit and 32 bit opcodes, listed in tables 4-3 to 4-5.

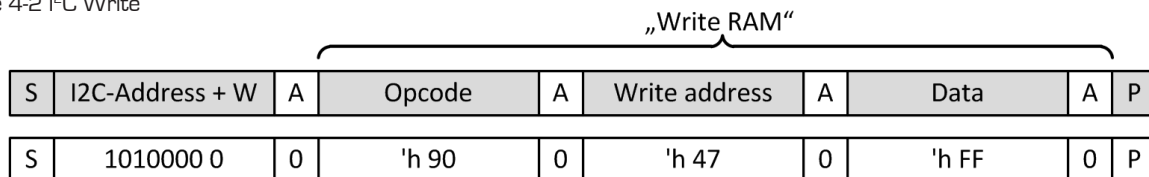
Figure 4-1: I²C principle sequence



I²C Write

During write transactions only the master sends data, the addressed slave just sends the acknowledge bits. The master sends first the slave address with the write bit. Then it sends the opcode including the register address in the slave. Finally it sends the data.

Figure 4-2 I²C Write

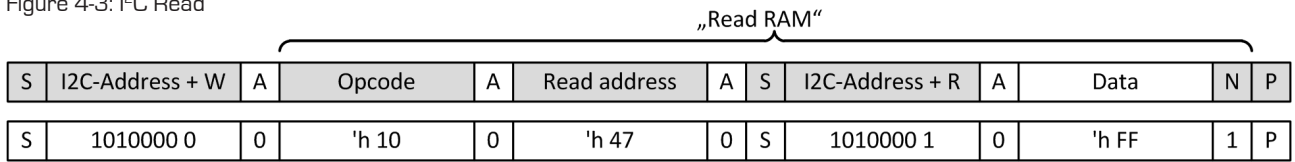


I²C Read

During read transactions the direction of communication has to be changed. Therefore the master sends again a start condition plus the slave address and the read bit (instead of the write bit) to switch into read mode. Figure 4-3

shows an example with opcode “read RAM”. The master sets a Not-Acknowledge [1] to indicate the end read to the slave.

Figure 4-3: I²C Read



4.1.3 The 4-wire, SPI interface

Clock Polarity, Clock Phase and Bit Order. The following choices are necessary for successful operation.

Table 4-1: SPI Clock Polarity, Clock Phase and Bit Order

SPI - Parameter	Description	Setting
CPOL	Clock polarity	0
CPHA	Clock phase	1
Mode	SPI Mode	1
DORD	Bit sequence order	0, MSB first

Timing conditions:

Figure 4-4: SPI Write

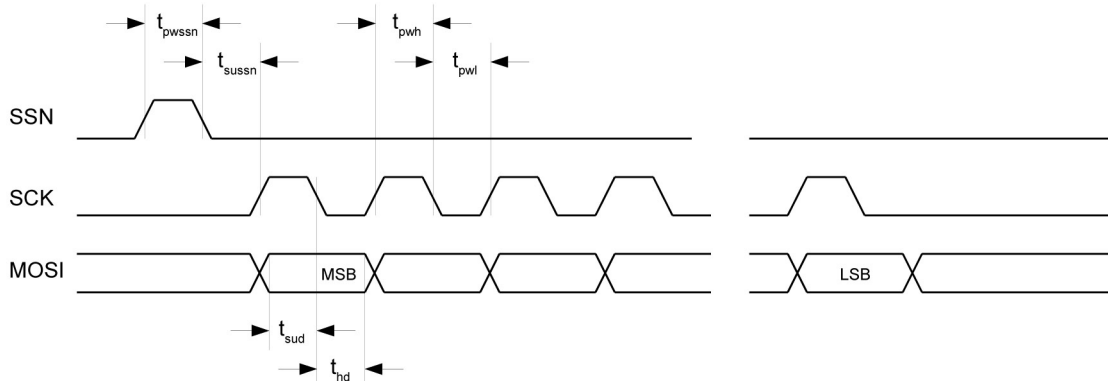


Figure 4-5: SPI Read

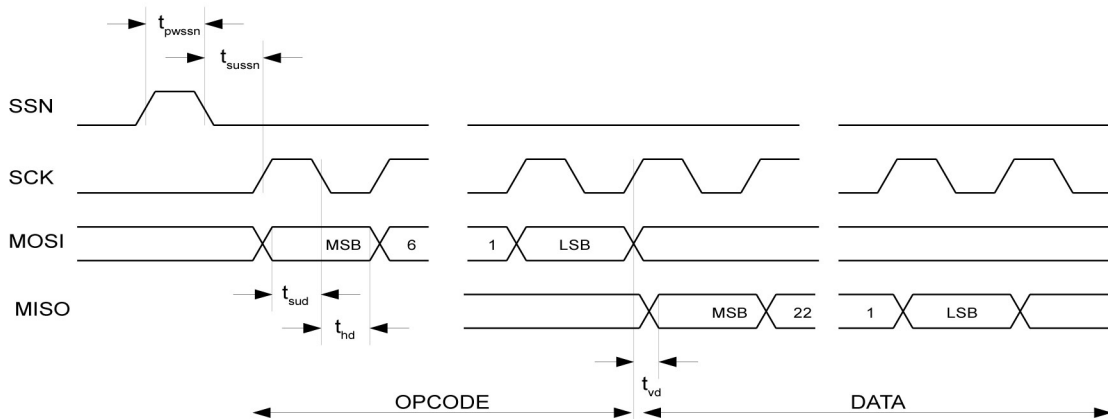


Table 4-2: SPI timing parameters

Name	Symbol	VDD=2.2 V	VDD=3.0 V	VDD=3.6 V	Units
Serial clock frequency	fSPI-bus	10	17	20	MHz
Serial clock pulse width HI state	tpwh	50	30	25	ns
Serial clock pulse width LO state	tpwl	50	30	25	ns
SSN enable-to-valid latch	tsussn	10	8	7	ns
SSN pulse width between write cycles	tpwssn	50	30	25	ns
Data setup time prior to clock edge	tsud	7	6	5	ns
Data hold time after clock edge	thd	5	4	3	ns
Data valid after clock edge	tvd	40	26	16	ns

Please jump to chapter 7 for an example of using the CDC part of the chip.

4.2 PDM/PWM and GPIO Pulse-Density / Pulse Width Code Interfaces and General-Purpose Ports

The following table shows the different general purpose ports and their possible assignment.

Table 4-6: General-Purpose Port Assignment:

External Port Name	Description	Direction in or out
PG0	SSN (in SPI-Mode)	in
	DSPØ or DSP2	in(1) / out
	FF0 or FF2	in(1)
	Pulse0	out
PG1	MISO (in SPI-Mode)	out
	DSP1 or DSP3	in(1) / out
	FF1 or FF3	in(1)
	Pulse1	out
PG2	DSPØ or DSP2	in(1) / out
	FF0 or FF2	in(1)
	Pulse0	out
	INTN	out
PG3	DSP1 or DSP3	in(1) / out
	FF1 or FF3	in(1)
	Pulse1	out
PG4	DSP4 (output only)	out
PG5	DSP5 (output only)	out

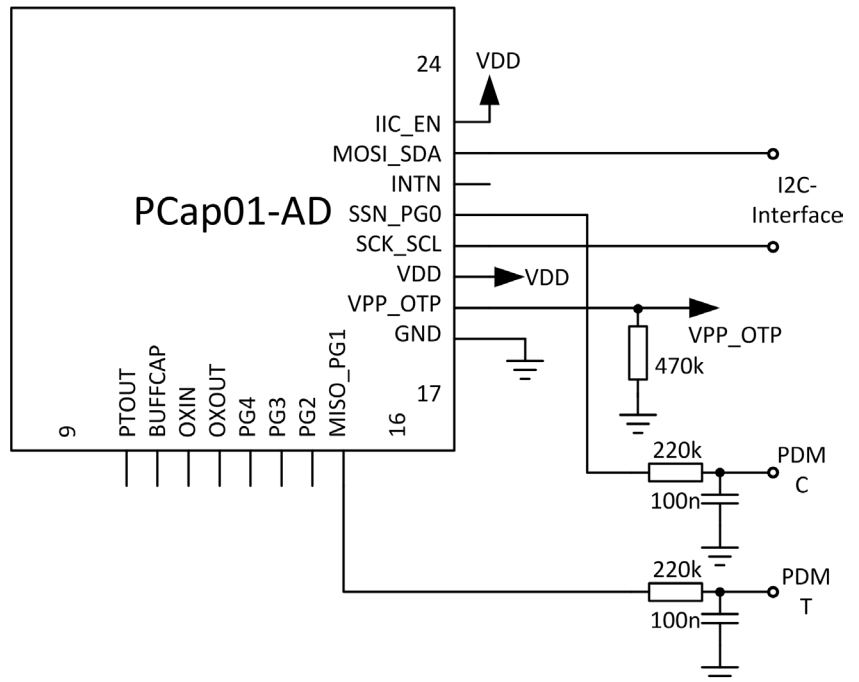
(1) These ports provide an optional debouncing filter and an optional pull-up resistor.

As one can see from above, the PGØ and PG1 are not available for pulse output when assigned to the SPI interface. In most cases where pulse outputs are wanted, SPI interface is used for programming only. In this case, after programming, the programmer is removed, pin/pad VPP_OTP is set LOW, and pin/pad IIC_EN is set HIGH. Once this is done, all PG ports are available for general-purpose use.

There is a possibility to generate pulse width or pulse density code as outputs from the chip, based on the measurement results. Any of the capacitance or temperature measurement results can be used to generate the pulsed output. The source of measurement to generate the pulsed output can be selected by setting the pulse1_select or pulse0_select in the register Param2. The pulse codes may be output through general-purpose ports PGØ and PG1. In I2C mode of communication, they can be optionally given out on PG2 and PG3, instead of PGØ and PG1. To enable this interchange of the pulsed outputs on PG0 and PG1 to PG2 and PG3, the bits PG0_X_G2 and PG1_X_G3 in Register 8 have to be set. In any case, the respective ports on which the pulses have to be given out are to be configured as output ports using the PG_DIR_IN bits in Register 9.

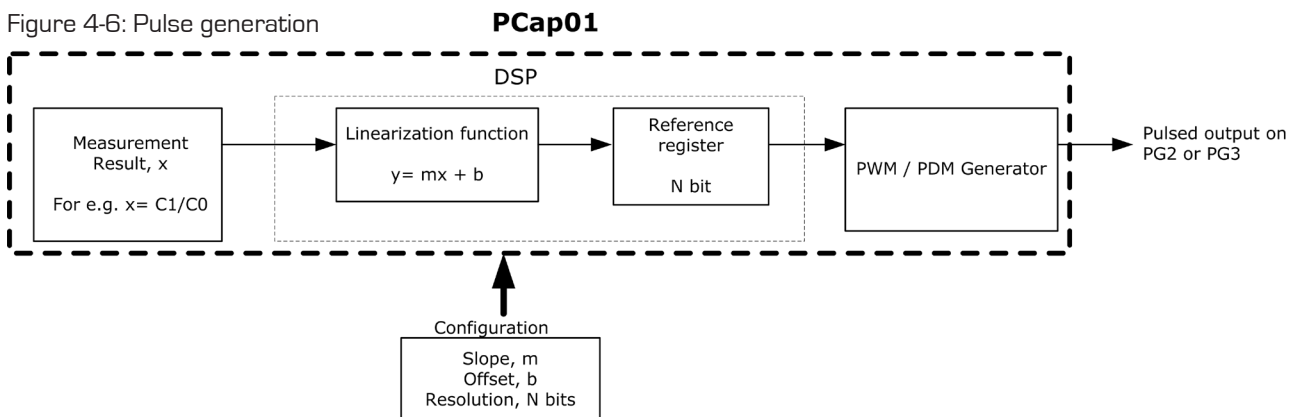
The pulse modulated outputs can be averaged using a Low Pass filter and an analog voltage can be obtained. The Pulse Width Modulated output need a low pass filter of higher order, while the Pulse Density Modulated output needs an LPF of lower order to generate the analog output. For the PDM output a combination of 220 kOhm / 100 nF offers less than 1 LSB output ripple.

Figure 4-5: PDM Output filtering



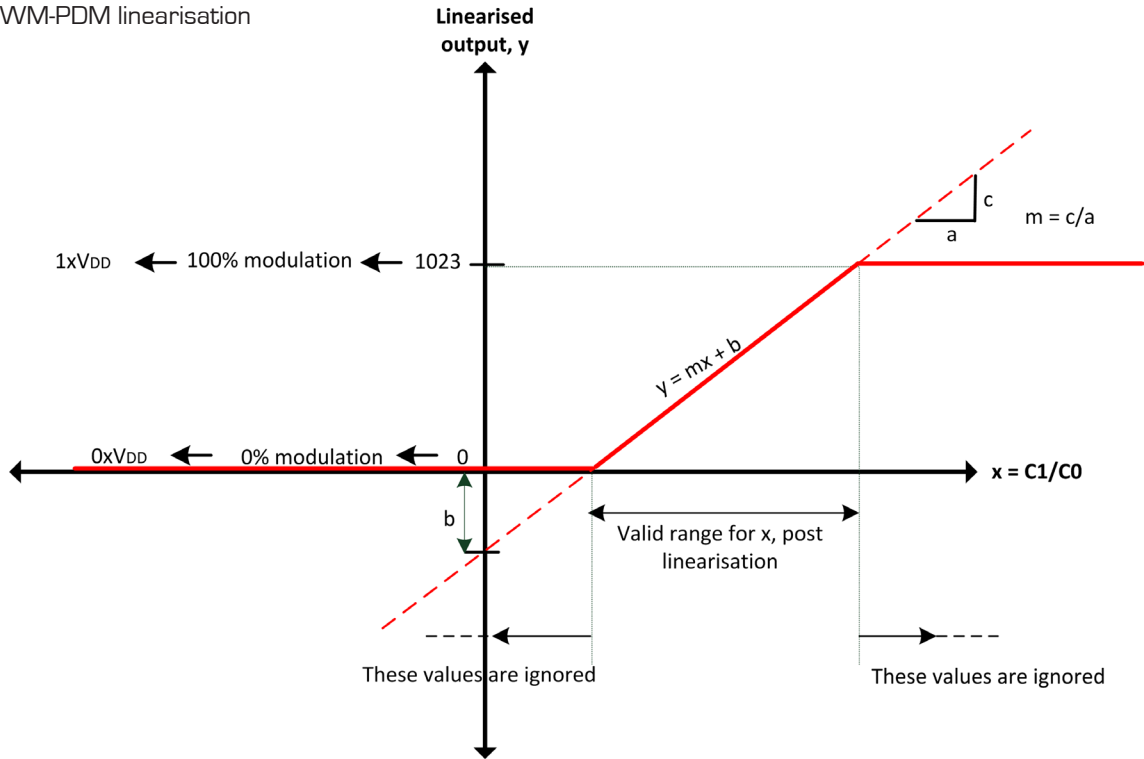
For generating the pulsed outputs, the frequency of the carrier clock signal is configurable to 8 MHz, 1MHz or 100 kHz. However it is recommended to use the LH_X2 100 kHz clock for best results. This can be selected by setting PI1_CLK_SEL or PIO_CLK_SEL in Register 9. The result of measurement from capacitance or temperature is a 24-bit value. The DSP linearizes this 24 bit result to a 10 bit value (for a 10 bit resolution setting); the parameters of the linear function are configurable using the parameters- Slope (m) and Offset (b) that can be set in Registers Param3 – Param5. Additionally the resolution of the Pulse interface also has to be configured using PI1_RES and PIO_RES in Register 9. Both the slope and the offset can be set to either positive or negative values. The setting of the slope and offset limits the range of the output signal and hence determine the voltage range of the filtered analog signal. The 10-bit resolution thus limits the result value between 0 and 1023. For lower bit resolutions, the range reduces accordingly. The following figure depicts how the result is processed to generate the pulsed output.

Figure 4-6: Pulse generation



The following figure shows a sample linear function and its parameters graphically. In this graph, the result C1/C0 has been taken on the x-axis, assuming that this result is to be pulse modulated. Here the value of m is positive and b is negative. 10 bit resolution has been configured.

Figure 4-7: PWM-PDM linearisation



By setting the value of m and b the linearization function limits the range of the output x as shown. Values outside these limits are ignored. Thereby knowing the range in which the results might change, the parameters of the linearization function can be fed accordingly. The lower limit of the valid range corresponds to 0% modulation (all bits are 0), this is the least possible value of the output (0). The upper limit of the valid range corresponds to 100% modulation (all bits are 1), and this is the maximum possible value of output. 10 bit resolution implies that this maximum value is 1023. For lower bit resolutions, this maximum value will come down accordingly. In terms of voltage the two limits correspond to 0V and Vdd.

Applications:

- A typical case would be outputting capacitance result through PGO and temperature result through PG1. Calculation and copying to the output registers must be performed by firmware. See help windows in the dedicated PCap01 assembler code editor.
- Applications for which reading the results out through the SPI/ I2C interface is not suitable because of speed limitations or applications requiring an analog output signal.
- A temperature-coded pulse stream could be low-pass filtered and then used for temperature control.

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5 Write & Read Registers

The PCap01Ax-V0301 with the standard firmware 03.01.xx offers 20 configuration and parameter registers and 12 read registers. The configuration registers cannot be read back. So, for communication test use the „Write to SRAM“ & „Read SRAM“ opcodes.

The configuration registers directly set the hardware like CDC, RDC, interfaces, clocks and DSP. The parameter registers set values in the firmware and therefore are firmware specific.

5.1 Configuration & Parameter Registers

Overview:

Address	Name	Description	Target
0	Register 0	OTP settings: MEMCOMP, ECC_MODE, AUTOBOOT_DIS, MEM_LOCK_DIS	Hardware
1	Register 1	Fixed default	Hardware
2	Register 2	C-measurement settings: CMESS_PORT_EN, CMEAS_BITS, RDCHG_INT_SEL	Hardware
3	Register 3	C-measurement settings: CY_CLK_SEL, SEQ_TIME, CMEAS_FAKE, C_AVRG	Hardware
4	Register 4	C/T-measurement settings: CMEAS_STARTPIN, CMEAS_TRIG_SEL, CMEAS_CYTIME, TMEAS_CYTIME, TMEAS_STARTPIN, TMEAS_TRIG_SEL	Hardware
5	Register 5	T-measurement settings: T_AVRG, TMEAS_TRIG_PREDIV	Hardware
6	Register 6	T-measurement settings: TMEAS_FAKE, TMEAS_7BITS	Hardware
7	Register 7	Fixed default	Hardware
8	Register 8	DSP configuration : DSP_SRAM_SEL, DSP_START, DSPSTARTONOV, DSP_STARTONTEMP, DSP_STARTPIN, DSP_FF_IN, DSP_WATCHDOG_LENGTH, DSP_MOFLO_EN, DSP_SPEED, INT2PG2	Hardware
9	Register 9	GPIO settings: PG_DIR_IN, PG_PULL_UP, PI_EN, PI1_CLK_SEL, PIO_CLK_SEL, PI1_RES, PIO_RES	Hardware
10	Register 10	Control of internal 1.8 V regulator	Hardware
11	Param0	Not used	Firmware
12	Param1	Not used	Firmware
13	Param2	Pulsed output setting: pulse_select	Firmware
14	Param3	Pulsed output setting: pulse0_slope	Firmware
15	Param4	Pulsed output setting: pulse0_offset	Firmware
16	Param5	Pulsed output setting: pulse1_slope	Firmware
17	Param6	Pulsed output setting: pulse1_offset	Firmware
18	Param7	C-measurement setting: differential	Firmware
19	Param8	Gain_Corr	Firmware
20	Register 20	RUNBIT	Hardware

Register Description in Detail:

Bit number →	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
parameter →	param1															
Recommended value →							1	1	0	0	1	0	1	0	1	0

Register 0 (address 0):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
								ECC_MODE								AUTOBOOT_DIS				MEM_LOCK_DIS			
0	1	0	0			1	0																

MEMCOMP

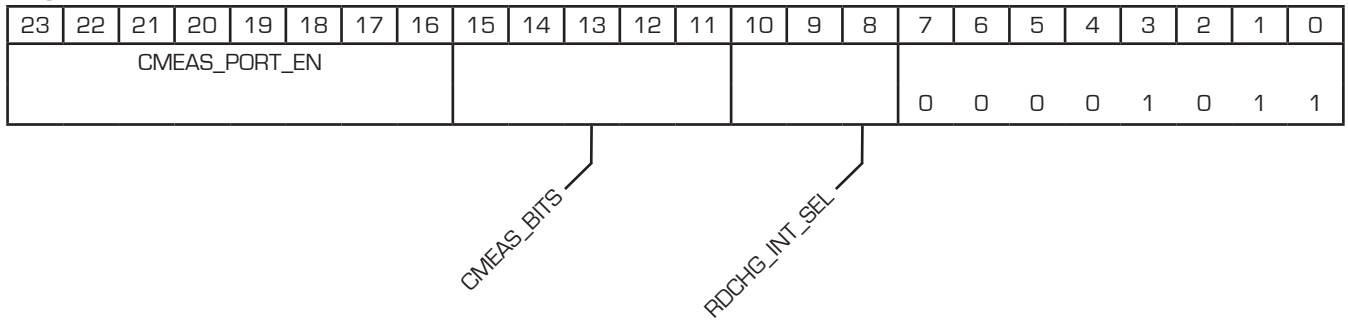
Parameter	Description	Settings
MEMCOMP	Bits 18 and 19 control the SRAM-to-OTP-comparison mechanism.	0 = disable 1 = 5 Byte 2 = 33 Byte 3 = 257 Byte
ECC_MODE	OTP-internal error detection and repair mechanism.	0x00 = Disabled („single“); limit=4032 Byte 0x0F = „Double“ mode; limit=4032 Byte 0xF0 = „Quad“ mode; limit=1984 Byte
AUTOBOOT_DIS	Automatic self boot from OTP	0x0 = stand-alone operation and the device then boots automatically from OTP. 0xF = slave operation and the device is interface booted.
MEM_LOCK_DIS		0x0 = activating the memory read-out blocker, which helps preventing the firmware from being read and thus protects your intellectual property. 0xF = Readout remains un-blocked

BYTE 0 (bits 7...0) cannot be written directly through the interface, but can only be copied from the OTP. This is part of the memory-secrecy mechanism protecting the OTP against reverse-engineering disassembly attempts.

Register 1 (address 1):

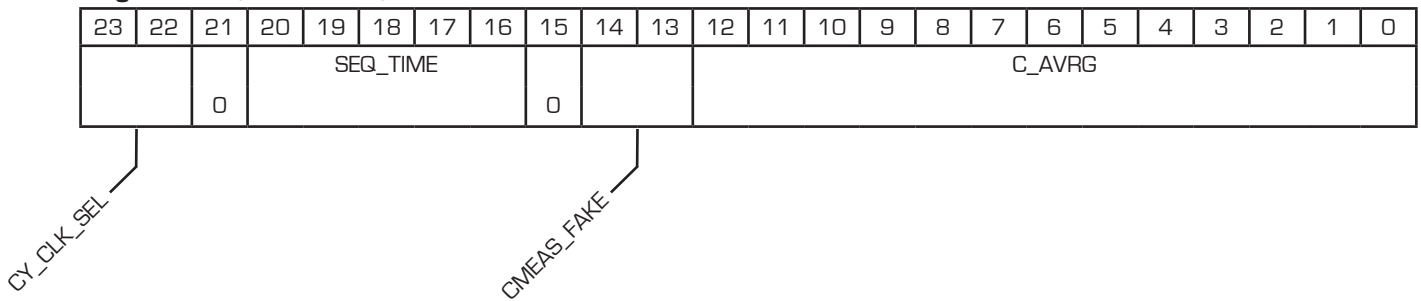
23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	1	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	1	0	0	0	1	0

Register 2 (address 2):

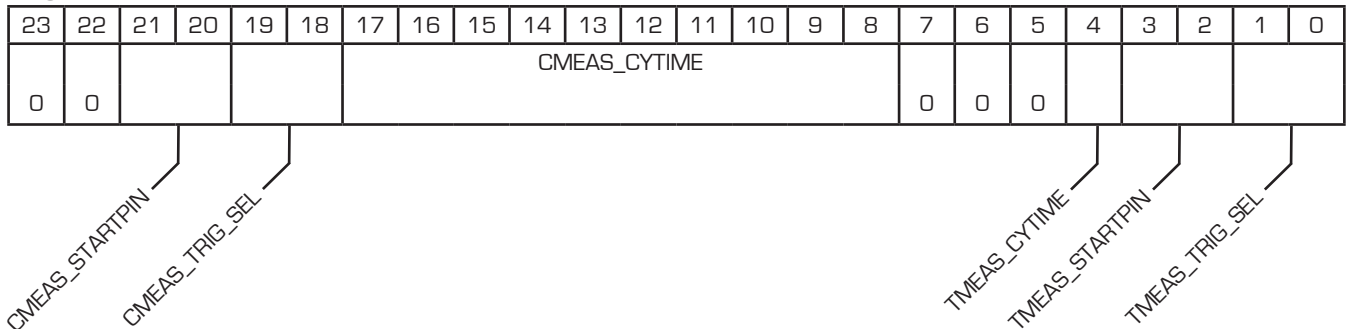


Parameter	Description	Settings
CMEAS_PORT_EN	CDC port mask	Bit 16 enables port PC0, bit 17 enables PC1 and so forth.
CMEAS_BITS	Sensor connecting scheme. See section 3.4	b'00010 = grounded capacitances, single or differential b'01000 = floating single capacitances b'10000 = floating differential capacitances
RDCHG_INT_SEL	Selection of internal discharge resistor	b'100 = 180 kOhm b'101 = 90 kOhm b'110 = 30 kOhm b'111 = 10 kOhm

Register 3 (address 3):



Parameter	Description	Settings
CY_CLK_SEL	CY_CLK_SEL fixes the time base for the CDC cycle, see dedicated chapter 6 below.	0 = 20 μs (to be used without a high frequency clock) 2 = 1 μs (only with ext. 4 MHz resonator) 3 = 0.25 μs (only with ext. 4 MHz resonator)
SEQ_TIME	Sets the trigger period in timer-triggered mode (register 4, TMEAS_TRIG_SEL = 2).	0 = off Otherwise, if s = SEQ_TIME, the trigger period will be 20 μs * 2^(s+1) with 1 ≤ s ≤ 24.
CMEAS_FAKE	Sets the number of CDC fake blocks per sequence, variable from zero to four.	
C_AVRG	Sample size for averaging the CDC results. Zero is ignored and counts as one.	The signal-to-noise ratio will approximately improve proportionally to the square root of C_AVRG

Register 4 (address 4):

Parameter	Description	Settings
CMEAS_STARTPIN	Selects the pin for pulse-triggered capacitance measurement	0 = PG0 1 = PG1 2 = PG2 3 = PG3
CMEAS_TRIG_SEL	Selects the trigger source for the capacitance measurement	0 = softwaretrigger only 1 = continuous mode 2 = timer-triggered mode 3 = pulse-triggered mode
CMEAS_CYTIME	Sets the cycle time for the capacitance measurement. See section 3 for details.	CDC cycle time = (CMEAS_CYTIME+1) * Clock_Period Clock_period=20µs / 1µs / 0.25 µs according to CYCLKSEL=0/2/3
TMEAS_CYTIME	Sets the cycle time for the temperature measurement. With 33nF,1000kOhm sensors set 0.	0 = 140 µs (recommended) 1 = 280 µs
TMEAS_STARTPIN	Selects the pin for pulse-triggered temperature measurement	0 = PG0 1 = PG1 2 = PG2 3 = PG3
TMEAS_TRIG_SEL	Selects the trigger source for the temperature measurement. Option 2 and 3 shall not be used.	0 = off/ opcode triggered 1 = CMEAS-triggered (by C-measurement, recommended) 2 = timer-triggered mode 3 = pulse-triggered mode

Begin with 0x041300 to be sure to get CDC values. Then increase or decrease your CDC cycle time according to your needs (linear scale). For first CDC tests, the RDC is better kept idle, that is why its trigger selector is kept zero.

Register 5 (address 5):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
TMEAS_TRIG_PREDIV																							

T_AVRG

Parameter	Description	Settings
T_AVRG	Sample size for averaging of RDC values	0 (1 = no averaging) 1 (4-fold averaging) 2 (8-fold averaging) 3 (16-fold averaging)
TMEAS_TRIG_PREDIV	Sets the occurrence of RDC measurements relative to CDC measurements.	Zero counts as one. Set zero for hygrometers, because temperature and humidity must be measured alike / Set 100...1k or more in pressure sensors, because pressure may vary quickly, much faster than temperature.

Register 6 (address 6):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
TMEAS_7BITS															0	1	0	0	0	0	0	0	

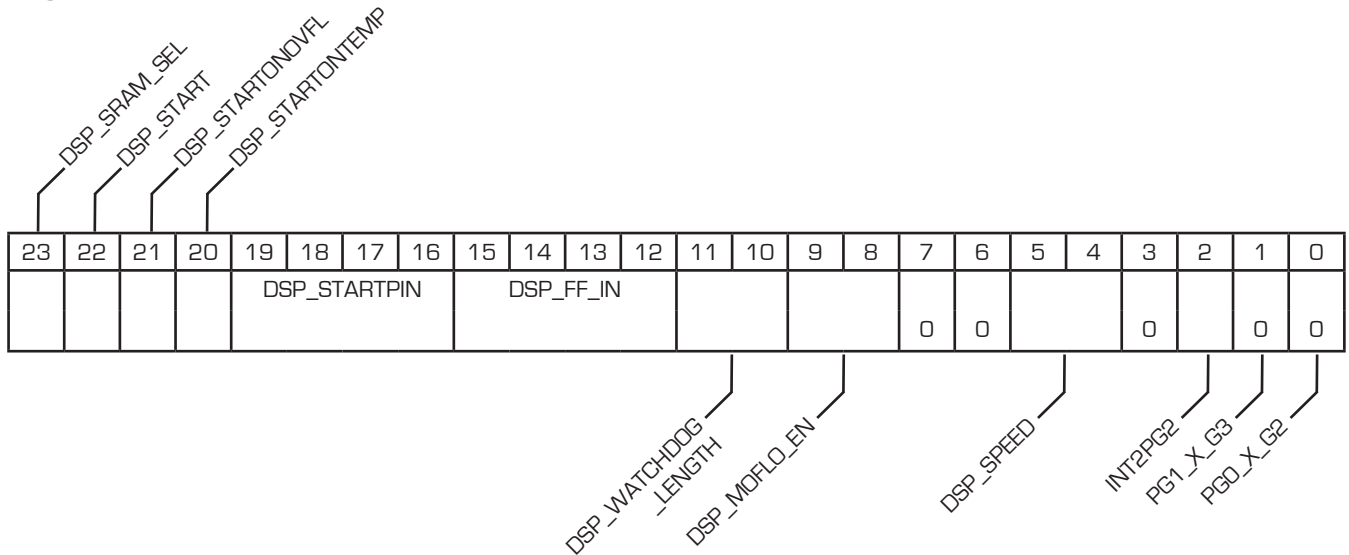
TMEAS_FAKE

Parameter	Description	Settings
TMEAS_FAKE	Select number of fake measurements. The resolution/precision may be better when = 1, but you will loose speed.	0 = 2 dummy measurements 1 = 8 dummy measurements
TMEAS_7BITS	See dedicated paragraph 5.2.6 below	

Register 7 (address 7):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	1	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Register 8 (address 8):

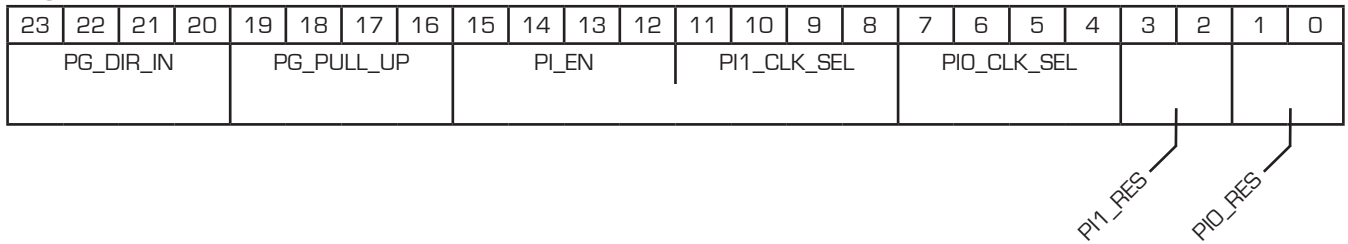


Parameter	Description	Settings
DSP_SRAM_SEL	Selects the program memory for the processor	0 = OTP 1 = SRAM
DSP_START	Start command for the processor; processor clock is started, program counter jumps to address zero and processing begins. After firmware completion, DSP stops its own clock!	
DSPSTARTONOVFL	This setting assures that processor starts upon error condition	0 = default is mandatory
DSP_STARTONTEMP	This setting assures that processor starts upon normal temperature measurement completion. Depends very much on firmware. In standard firmware 03.01.xx temperature values are determined after CDC-determination.	0 = default, mandatory with standard firmware 03.01.xx
DSP_STARTPIN	Pin mask for latching flip-flop activation	0 = PGO 1 = PG1 2 = PG2 3 = PG3
DSP_FF_IN	Pin mask for latching flip-flop activation	Bit 12 = PGO Bit 13 = PG1 Bit 14 = PG2 Bit 15 = PG3
DSP_WATCHDOG_LENGTH	Processor watchdog to be defined in connection with the software developer	
DSP_MOFLO_EN	Activates anti-bouncing filter in PGO and PG1 lines	Bit 9 for PG1 Bit 8 for PGO

DSP_SPEED	Setting the DSP speed	1 = standard (fast) 3 = low-current (slow)
INT2PG2	Useful with QFN24 packages, where no INTN pin is available. Permits rerouting the interrupt signal to the PG2 port.	
PG1_X_G3	The pulse codes is output typically at ports PG0 and PG1. In I2C mode of communication, they can be optionally given out on PG2 and PG3, instead of PG0 and PG1.	0 = PG1 1 = PG3
PG0_X_G2		0 = PG0 1 = PG2

See dedicated chapter below. Set 0x800010 to start with. The low-current setting might be incompatible with high speed measurments.

Register 9 (address 9):



Parameter	Description	Settings	
PG_DIR_IN	toggles outputs to inputs (PG3/bit23 to PG0/bit20).	0 = output 1 = input	
PG_PULL_UP	Activates pull-up resistors in PG0 to PG3 lines; useful for mechanical switches.	Bit 16 = PG0 Bit 17 = PG1 Bit 18 = PG2 Bit 19 = PG3	
PI_EN	enables pulse-density or pulse-width mode code generation. PWM0/PDM0 can be output at ports PG0 or PG2. PWM1/PDM1 can be output at ports PG1 or PG3.	b'xx01 = PWM0 on b'xx10 = PDM0 on b'01xx = PWM1 on b'10xx = PDM1 on	
PI1_CLK_SEL	Base frequency for the pulse code interfaces, based on the internal low-frequency oscillator [OLF] or the external high frequency oscillator [OHF]	4 = OHF * 2	8 = OLF * 2
PIO_CLK_SEL		5 = OHF	9 = OLF
		6 = OHF / 2	10 = OLF / 2
		7 = OHF / 4	11 = OLF / 4
PI1_RES	Resolution of the pulse code interfaces	0 = 7 bit	
		1 = 8 bit	
PIO_RES		2 = 9 bit	
		3 = 10 bit	

Try 0xFF000F to get started

Register 10 (address 10):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	1	1	0	0	0	0	0	0	0	0	0	0	0	V_CORE_CTL							

Parameter	Description	Settings
V_CORE_CTL	Controls the 1.8 V core voltage regulator. The low-current setting permits a better resolution but puts restrictions onto RDC speed and timing. See the example in the appendix.	0x47 = Standard 0x87 = Low-current

Param0 (address 11): not used

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	

Param1 (address 12): not used

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	

Param2 (address 13):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
																	pulse1_select			pulse0_select			

Parameter	Description	Settings																				
pulse0_select pulse1_select	Select the source for the PDM/PWM outputs	<table border="1"> <thead> <tr> <th>single</th> <th>differential</th> </tr> </thead> <tbody> <tr> <td>1 = C1/C0</td> <td>1 = C1/C0</td> </tr> <tr> <td>2 = C2/C0</td> <td>2 = C3/C2</td> </tr> <tr> <td>3 = C3/C0</td> <td>3 = C5/C4</td> </tr> <tr> <td>4 = C4/C0</td> <td>4 = C7/C6</td> </tr> <tr> <td>5 = C5/C0</td> <td></td> </tr> <tr> <td>6 = C6/C0</td> <td></td> </tr> <tr> <td>7 = C7/C0</td> <td></td> </tr> <tr> <td>8 = R0/Rref</td> <td>8 = R0/Rref</td> </tr> <tr> <td>9 = R2/Rref</td> <td>9 = R2/Rref</td> </tr> </tbody> </table>	single	differential	1 = C1/C0	1 = C1/C0	2 = C2/C0	2 = C3/C2	3 = C3/C0	3 = C5/C4	4 = C4/C0	4 = C7/C6	5 = C5/C0		6 = C6/C0		7 = C7/C0		8 = R0/Rref	8 = R0/Rref	9 = R2/Rref	9 = R2/Rref
single	differential																					
1 = C1/C0	1 = C1/C0																					
2 = C2/C0	2 = C3/C2																					
3 = C3/C0	3 = C5/C4																					
4 = C4/C0	4 = C7/C6																					
5 = C5/C0																						
6 = C6/C0																						
7 = C7/C0																						
8 = R0/Rref	8 = R0/Rref																					
9 = R2/Rref	9 = R2/Rref																					

Param3 (address 14):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
pulse0_slope																							

Parameter	Description	Settings
pulse0_slope	Slope for pulse output 0. Signed fixed-point number with 19 integer, 4 fractional digits	-524,288 to +524,288 in steps of 0.0625

Param4 (address 15):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
pulse0_offset																							

Parameter	Description	Settings
pulse0_offset	Offset for pulse output 0. signed fixed-point number with 22 integer, 1 fractional digits. The fractional digit is used for mathematical rounding, it is not used for the output.	-4,194,304 to + 4,194,303.5 in steps of 0.5

Param5 (address 16):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
pulse1_slope																							

Parameter	Description	Settings
pulse1_slope	Slope for pulse output 1. Signed fixed-point number with 19 integer, 4 fractional digits	-524,288 to +524,288 in steps of 0.0625

Param6 (address 17):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
pulse1_offset																							

Parameter	Description	Settings
pulse1_offset	Offset for pulse output 1. signed fixed-point number with 22 integer, 1 fractional digits. The fractional digit is used for mathematical rounding, it is not used for the output.	-4,194,304 to + 4,194,303.5 in steps of 0.5

Param7 (address 18):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	

differential

Parameter	Description	Settings
differential	Selects between single and differential sensors	0 = Single 1 = differential

Param8 (address 19):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
Gain_Corr																								

Parameter	Description	Settings
Gain_Corr	Multiplication factor for internal compensation measurement. Unsigned fixed-point number with 3 integer and 21 fractional digits.	0 to 7.9999..

Register 20 (address 20):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

RUNBIT

Parameter	Description	Settings
RUNBIT	RUNBIT must be the last parameter written.	0 = protects the device and keeps it idle during configuration and forces the DSP to stand still. 1 = activates run mode

5.2 Explanations to Configuration Registers

5.2.1 Comments on Register 0

Register 0 is the first in the list, and the last to be handled, as it applies to the OTP memory. So, during most of the evaluation and design-in, it will be unimportant.

MEMCOMP: Setting 0x0 is mandatory if DSP_SRAM_SEL='OTP'. Otherwise 0x2 may be best choice; upon firmware „stop“, the DSP clock will be slowed down, and SRAM contents will be compared to OTP in 33-byte parcels. Next parcel after next stop. Upon comparison alert, MEMCOMP issues a power-up reset. Through AUTOBOOT, the SRAM contents will be refreshed.

ECC_MODE. When not disabled („single“), this mechanism stocks and compares OTP contents in redundancy, see OTP memory map in annex. Recommended setting is 0xF0 („quad“) for firmware length < 1985 bytes and 0x0F („double“) above. Quad mode simply means triple copy of every bit and AND connection between each (note: accidental zero-to-one bit shift is possible, whereas one-to-zero is not). Double mode resides on a Hamming Code parity test. Errors are corrected, as far as possible (but not repaired).

With AUTOBOOT_DIS = 0xF any automatic boot option after a power-on reset is disabled. The chip will wait for the serial interface to write the firmware into the SRAM and to write appropriate data to the configuration and parameter registers.

5.2.2 Comments on Register 2

BYTE 1: Recommended CMEAS_BITS values are:

Table 5-1: Settings for CMEAS_BITS

for single capacitances connected floating	5b'01000
for single capacitances connected to ground	5b'00010
for differential capacitances connected floating	5b'10000
for differential capacitances connected to ground	5b'00010

Some differential capacitors require a mirror symmetric charge/discharge process to neutralize mechanical stress. This option is activated through Bit 13 = ,1'. Also Param7 register has to be set to select between single and differential sensors.

Select the chip-internal discharging resistor (RDCHG_INT_SEL) as follows:

Table 5-2: Settings for parameter RDCHG_INT_SEL

Consider the largest sensor capacitance in your set-up and include stray capacitance (average 10 to 40 pF each). Also consider your reference capacitor including stray capacitance as above. Take the largest value of all and call it C_ largest.			
If C largest	< 100 pF	RDCHG_INT_SEL	= b'100 (180 kOhm)
	< 300 pF		= b'101 (90 kOhm)
	< 1 nF		= b'110 (30 kOhm)
	< 3.5 nF		= b'111 (10 kOhm)

5.2.3 Comments on Register 3

The benefit from using fake measurements depends on the individual sensors. Experiment with different settings. With the averaging setting, begin with sample size = CMEAS_AVRG = 1. Increasing this value gives better resolution, but lowers the measurement rate.

5.2.4 Comments on Registers 3 and 4 (timing rules)

Timing the CDC and RDC measurement depends on notions like „cycle time“ and „sequence time“ (See chapter 3). A cycle is an elementary process; it consists of just one charging and subsequent discharging the individual sensor paths, be it 100 μ s or even several milliseconds in extreme cases, the lower limit is 0.25 μ s for the CDC part of the device. - Always make sure to let sufficient time for the charging process, because the discharging is conditioned physically via the real values of capacitance and resistivity. Let as much time for charging as for the discharging as minimum.

Too short a cycle time will lead to error conditions (time-out and port error on one or several ports). Inadequate cycle time will increase the noise. Sometimes the capacitances at hand are not known precisely. Especially, cable capacitances and other stray capacitances are not known. During design and debugging, it may be wise to start with large cycle times before trying to optimize this parameter down. Cycle time cannot be fixed individually to every port; rather there is one general cycle time for the CDC and one other for the RDC.

„Sequence Time“ is another word for „on-chip generated trigger period“. Sequence time is not always important. It is useful when low-noise measurements must be made „from time to time“, with some milliseconds, seconds or up to eleven minutes of idle time in between. Saving current may be one aspect. Conversely, the sequence-time parameter is ignored when the chip is operated in a continuous mode where the last cycle of a preceding measurement triggers the first cycle of the next one.

Continuous mode is commanded through CMEAS_TRIG_SEL=1 and TMEAS_TRIG_SEL=1 (or 0 which disables the RDC). Single-conversion is always possible through op-code commands or DSP commands. It is furthermore possible though CMEAS_TRIG_SEL=2 and triggered through a sequence timer according to parameter SEQ_TIME (in this and only in this case this parameter counts). Third, it is possible through CMEAS_TRIG_SEL=3 and electric pulses introduced through one of the general-purpose ports. Which one, is fixed through parameter ..._STARTPIN.

5.2.5 Comments on Registers 4 and 5

When neither power-saving nor external synchronization is an issue, choose CMEAS_TRIG_SEL=1 (recommended) and TMEAS_TRIG_SEL=1. TMEAS_TRIG_PREDIV=1, maximizes the number of temperature measurements, which is probably too many. With TMEAS_TRIG_PREDIV=64, there will be one temperature measurement run for every 64 CDC measurements. Similarly the RDC trigger pre-divider divides the number of LF clock cycles (with period approx. 20 μ s) when the trigger source is chosen TMEAS_TRIG_SEL=2 (not recommended). With the TMEAS_CYTIME setting, try both possible choices. Setting this to 1, you are on the safe side, but may lose speed.

5.2.6 Comments on Register 6

The chip device contains an internal thermo-resistance and an internal reference resistor. Furthermore it provides three external ports for connecting thermometers/reference. All in all, 11 combinations are supported by the chip. Standard firmware, though, as presented here, limits to six combinations out of eleven:

Option#	Reference Resistor	External Resistor	Internal Resistor
1	Internal	None	Connected, active
2	Internal	Connected to port PTO	Connected, active
3	Internal	Connected to port PTO	Connected, inactive
4	External connected at port PT2REF	None	Connected, active
5	External connected at port PT2REF	Connected to port PTO	Connected, active
6	External connected at port PT2REF	Connected to port PTO	Connected, inactive

For any of these 6 combinations, choose parameter TMEAS_7BITS and read the results in the output registers as follows:

Option#	TMEAS_7BITS	Contents of output registers
1	1000011 = 'h43	Res11 = R{AI_internal}/R{Si_internal}
2	1001011 = 'h4B	Res10 = R{external}/R{Si_internal} Res11 = R{AI_internal}/R{Si_internal}
3	1001001 = 'h49	Res10 = R{external}/R{Si_internal}
4	0000110 = 'h06	Res11 = R{AI_internal}/R{Ref_external}
5	0001110 = 'h0E	Res10 = R{external}/R{Ref_external} Res11 = R{AI_internal}/R{Ref_external}
6	0001100 = 'h0C	Res10 = R{external}/R{Ref_external}

5.2.7 Comments on Register 8

It is recommended that you use the setting 0x800030 as mentioned to get started in slave operation. Choose 0xA00030 for stand-alone applications. Parameter WATCHDOG should be defined together with the firmware developer. When using standard firmware (cf. chapter 7....?), the watchdog may be used and WATCHDOGLength = 3 may be a good choice. Zero disables the watchdog.

Setting INT2PG allows the interrupt line to be outputted through the PG2 port (useful with 24-pin packages where there is no INTN pin.). Using the Interrupt technique is preferred to polling the interface to minimize noise.

5.2.8 Comments on Register 9

Further details concerning the pulse code interface must be fixed in collaboration with the firmware developer.

5.3 Read Registers

The read registers content is firmware specific. It depends on the program that runs in the DSP. With the standard firmware O3.01.xx the registers have the following content:

Address	Name	Content	Description
0	Res 0	C0 LSB	For reference only: normalized TDC value in LSB
1	Res 1	C1/C0	Single C: ratio C1/C0 Differential C: ratio C1/C0
2	Res 2	C2/C0 or C3/C2	Single C: ratio C2/C0 Differential C: ratio C3/C2
3	Res 3	C3/C0 or C5/C4	Single C: ratio C3/C0 Differential C: ratio C5/C4
4	Res 4	C4/C0 or C7/C6	Single C: ratio C4/C0 Differential C: ratio C7/C6
5	Res 5	C5/C0	Single C: ratio C5/C0
6	Res 6	C6/C0	Single C: ratio C6/C0
7	Res 7	C7/C0	Single C: ratio C7/C0
8	Status	Status	Status information
11	Res 8	not used	
12	Res 9	not used	
13	Res 10	R0/Rref	Ratio Sensor 0 to reference
14	Res 11	R2/Rref	Ratio Sensor 2 to reference

See figures 3-3 to 3-6 for a description of what C0 to C7 means.

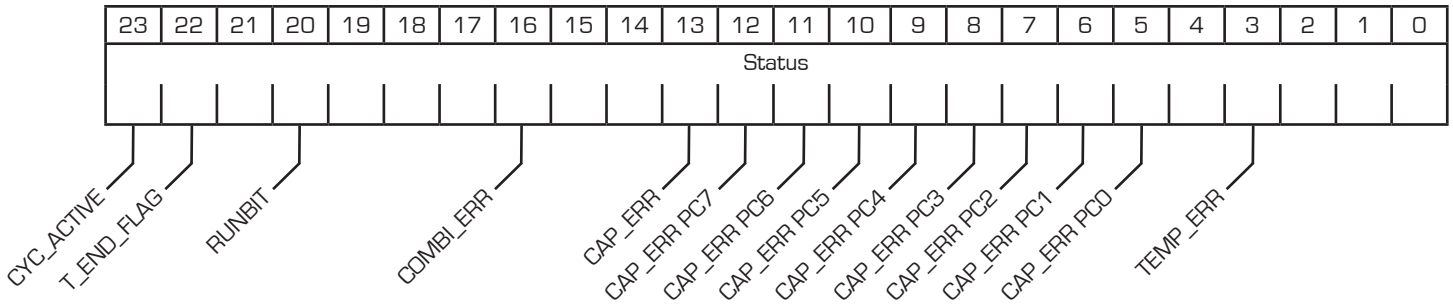
Register Description in Detail:

Res1 (address 1) to Res7 (adr7):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Cx/Cy																							
integer			fractional																				

Parameter	Description	Data range
C1/C0 etc.	Capacitance ratios. Unsigned fixed-point numbers with 3 integer and 21 fractional digits.	0 to 7.9999 resolution 0.477 ppm

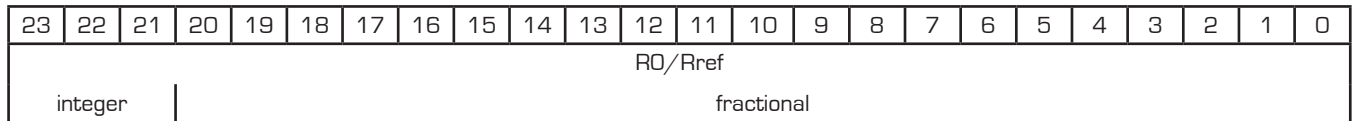
Status (address 8):



Bit	Flag name	Description
23	CYC_ACTIVE	Indicates that interface communication took place during the measurement; the measurement quality may suffer due to this; increasing the sequence time may help
22	T_END_FLAG	Indicates the end-of-temperature measurement condition; according to the settings made, this may indicate that the device is waiting for a start command or for the next timer-triggered start condition
20	RUNBIT	Gives back the setting of the RUNBIT in configuration register 20
16	COMBI_ERR	This is a combined condition of all known error conditions
13	CAP_ERR	Indicates an overflow or other error in the CDC.
12 to 5	CAP_ERR_PC	Indicates a port error on any CDC port (possibly too big capacitance)
3	TEMP_ERR	Indicates an overflow or other error in the RDC

Please ignore all status bits not mentioned here.

Res10 (address 13):



Parameter	Description	Data range
RO/Rref	Resistance ratios from temperature measurement. - RO is the external resistor connected to port PTO. - Rref might be the external reference connected to port PT2REF or the internal Poly resistor. Unsigned fixed-point numbers with 3 integer and 21 fractional digits.	0 to 7.9999 resolution 0.477 ppm

Res11 (address 14):

23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
integer			R2/Rref																				
			fractional																				

Parameter	Description	Data range
R2/Rref	Resistance ratios from temperature measurement. - R2 might be the external resistor connected to port PT2 or the internal Aluminum resistor. - Rref might be the external reference connected to port PT2REF (only with RO = internal Aluminum) or the internal Poly resistor. Unsigned fixed-point numbers with 3 integer and 21 fractional digits.	0 to 7.9999 resolution 0.477 ppm

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6 DSP, Memory & Firmware

6.1 DSP Management and Programming

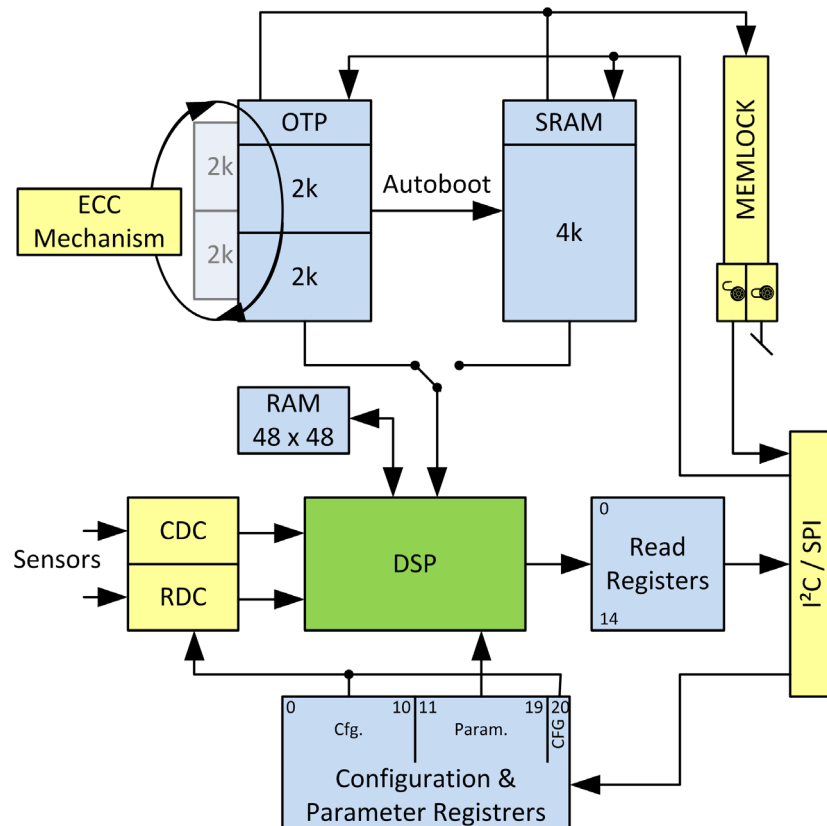
A digital signal processor (DSP) in Harvard architecture has been integrated. It is programmable and responsible for the content of the read registers. The software, called “firmware”, is either available ready-made from acam or can be user-written. In this datasheet we describe only the standard firmware 03.01.xx as it is provided by acam. This firmware writes the compensated capacitance ratios and the resistance ratios to the read registers, without any further data processing like linearization or filtering.

This DSP for 48 bit wide parallel data processing is coupled to a 48 x 48 bit RAM and is internally clocked at approximately 100 MHz. The internal clock is stopped through a firmware command, to save power. The DSP starts again upon a GPIO signal or an “end of measurement run” condition.

The DSP is acam proprietary to cover low-power tasks as well as very high data rates. It is programmed in Assembler [no high-level language is available]. A user-friendly assembler software with a graphical interface, helptext pop-ups as well as sample code sustain programming efforts. Subroutines can be coded.

The DSP signals a “data ready” state to an interrupt line. The interrupt may be picked either from the INTN port or from GPIO (PG2). Using the interrupt technique has some advantages with respect to noise and power consumption, also avoiding to read one and the same result several times. This is likely to happen when polling the interface; it may be avoided though, by careful timing and synchronizing.

Figure 6-1 DSP & Memory



6.2 Memory Map

Table 8-1 Memory organization

		SRAM		OTP							
Address				direct/single		double		quad			
dec.	hex.	Contents	Length [Byte]	Contents	Length [Byte]	Contents	Length [Byte]	Contents	Length [Byte]		
4095	FFF	Program code	4096	Unused	1	Test byte	1	Test byte	1		
4094	FFE			Config. Registry	63	Config. Registry	63	Config. Registry	63	Config. Registry	63
4032	FC0										
4031	FBF			Program code	4032	Program code	4032	Program code	4032	Program code	1984
2048	800h									Test byte	1
2047	7FF									Config. Registry	63
2046	7FE									Program code	1984
1984	7C0										
1983	7BF										
0	0			Program code	4096	Program code	4032	Program code	4032	Program code	1984

6.3 Memory Management

The DSP can be operated from SRAM (maximum speed) or from OTP (low power). When operated from SRAM, an SRAM-to-OTP data integrity monitor can be activated through parameter MEMCOMP in register 0, but must(!) be inactivated for operation directly from OTP.

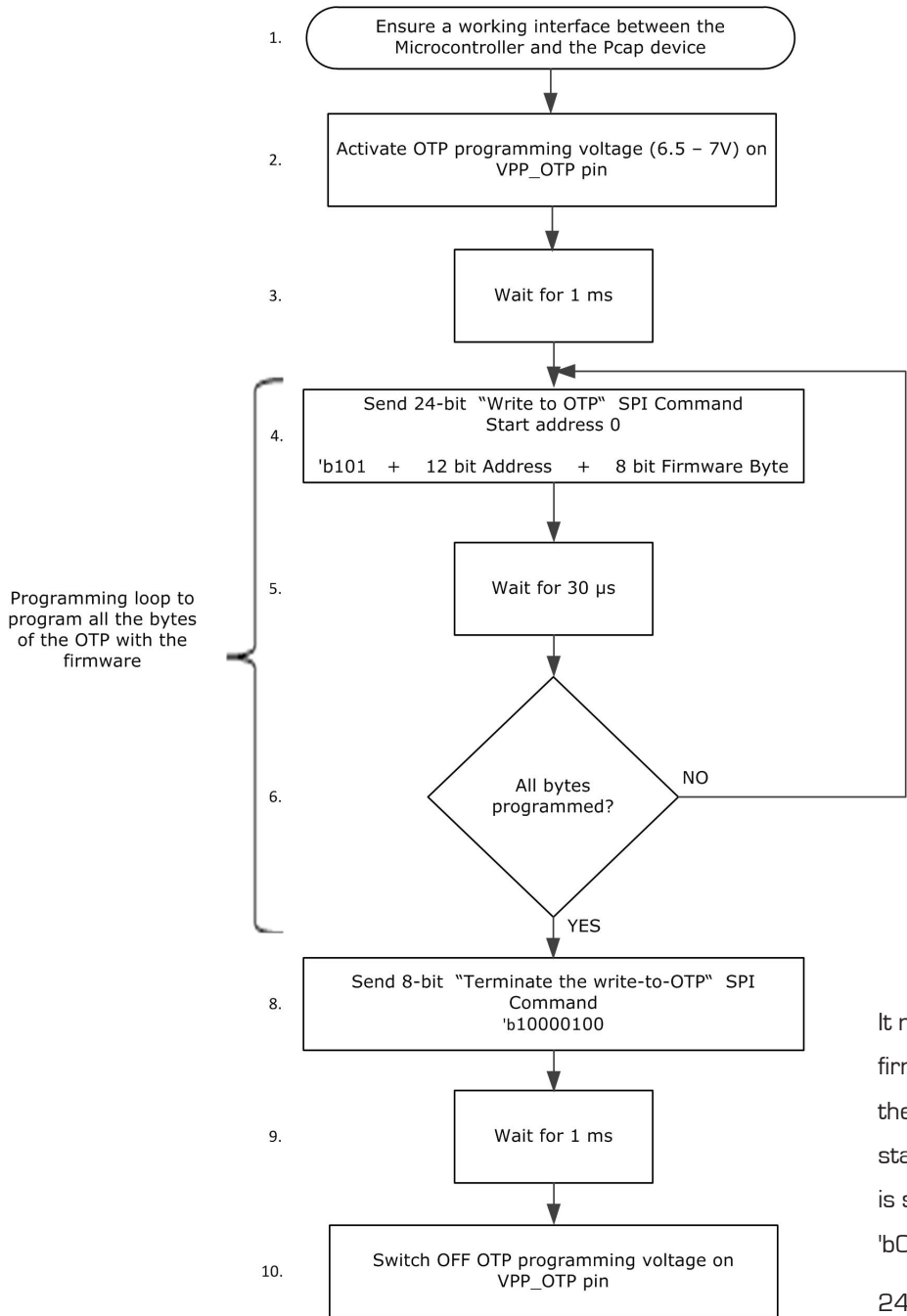
Memory integrity (“ECC”) mechanisms survey the OTP contents internally and correct faulty bits (as far as possible).

Activate MEMLOCK, the memory readout blocker, through special OTP settings performed when loading down the firmware (see the graphical user interface existing for firmware development). MEMLOCK contributes to the protection of your intellectual property. MEMLOCK gets active earliest after it was written to the OTP and the chip got a power-on reset.

6.4 OTP Firmware programming

The PCap device is equipped with a 4 kB permanent program memory space, which is one-time programmable, called the OTP memory. In fact, the OTP is total 8 kB in size but 4 kB are used for ECC mechanism. The default state of all the bits of the OTP memory in an un-programmed state is ‘High’ or 1, i.e. 0xFF byte-wise. Programming a bit means changing its state from High to Low. Once a bit is programmed to 0, it cannot be programmed back to 1. Data retention is given for 10 years at 95°C. MEMLOCK is fourfold protected.

To program a bit in the OTP to Low or '0', an external programming voltage of 6.5 V is necessary. This voltage must be supplied to pin VPP_OTP for programming. Hence it is impossible that an un-programmed bit would be programmed to 0 spontaneously during ordinary operation, when the VPP_OTP pin is grounded.. The following flowchart shows the sequence of steps to be performed to program the firmware into the OTP:

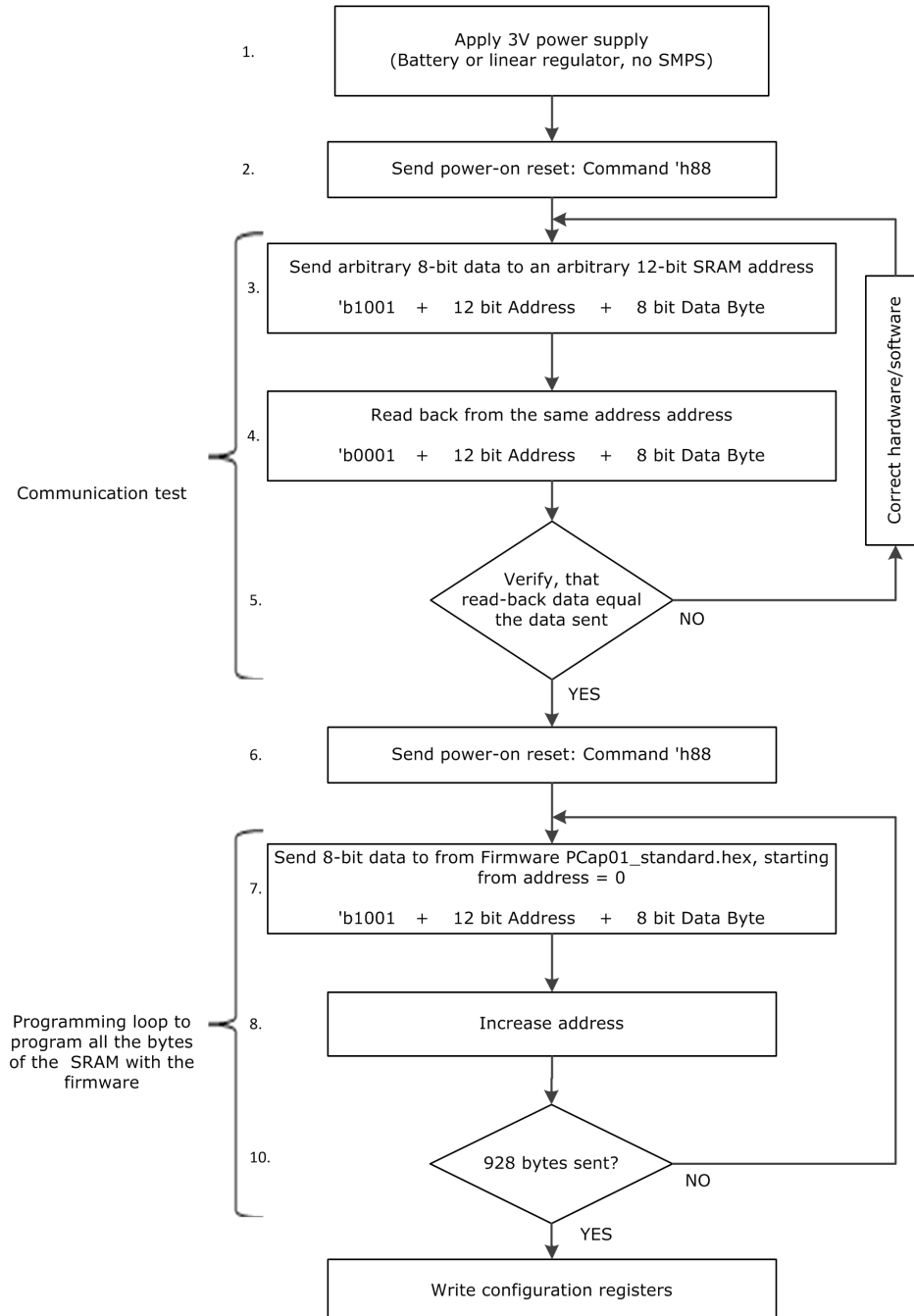


It may be good practice to read the firmware back and compare, at least the first 960 bytes in the case of the standard firmware. The read command is similar to the write command with 'b001 for the leading bits:
24-bit COMMAND_READ = 'b001 + 12-bit ADDRESS + 8-bit Firmware-byte

6.5 Getting Started

6.5.1 SRAM Firmware programming

During software development, evaluation and also in many applications the user might want to use the SRAM as program memory, not the OTP. Therefore, after a power-on reset it is first necessary to write the firmware into the SRAM. By means of opcodes „Write to SRAM“ and „Read SRAM“ it is possible to read from or write to arbitrary addresses of the SRAM. The following flowchart shows the first steps after a power on Reset.



6.5.2 Configuration, Example 1

The next step after downloading the firmware is to download the configuration.

This example refers to a basic configuration like Pcap01_standard.cfg (as it comes with the evaluation kit).

This example features:

Capacitance	Temperature	Others
Single grounded capacitors 1 sensor, 1 reference, internally compensated Rdisch = 30 kOhm, 20 µs cycle time 3 Hz data rate Averaging 100 samples	Off	Sequence time triggered

The configuration in detail is the following:

```

Register 0:      'h 42 00 FF
Register 1:      'h 20 10 22
Register 2:      'h 03 1E 0B
Register 3:      'h 0D 00 64
Register 4:      'h 08 00 00
Register 5:      'h 00 00 00
Register 6:      'h 00 00 40
Register 7:      'h 1F 00 00
Register 8:      'h 80 00 30
Register 9:      'h FF 00 0F
Register 10:     'h 18 00 87
    
```

1. In order to write these 24-bit parameters, use the following 32-bit format:

```
{2'b01, 5'b<Result_Address>, 23'b<Result_Data>}
```

When all eleven registers are configured, finish with setting the runbit in Register 20:

```
{2'b11, 5'b10100, 'h000001}
```

2. Now the chip is ready and measurement can begin. Send a partial reset ('h8A), but not a power-up reset!

3. Next, send a start command ('h8C).

4. Wait half a second, then read the status register (address 8) and results (addresses 0 and 1). For reading 24-bit status and results use the following 32-bit format:

```
{2'b01, 5'b<Result_Address>, 23'b<Result_Data>}
```

It is expected to find status=='h100000 or 'h900000.

Res0 could be e.g. in the range of 70000. This integer value, multiplied by typ. 21ps resolution gives an indication of the discharge time measured. With 70000 we would have a discharge time of 1.5 μ s. Of course, this value depends on the capacitors used.

Res1 is expected to be in the range of 2,000,000 or 'h1FF2XX if the two capacitors are of same size. Res1 has the format of a fixed point number with 3 integer digits and 21 fractional digits. So, dividing the 2,000,000 by 2^{21} gives a factor of about 1 for the ratio $C1/C0$.

Now some words of caution, the 21 ps value is a typical value at room temperature and 3 volts. It may vary greatly over temperature it may also be batch-dependent. However, it is very constant on a sub-millisecond timescale. That is why we recommend a relative measurement between a sensor and a reference.

6.5.3 Configuration, Example 2

This example refers a capacitance measurement together with a temperature measurement (internal sensor).

This example features:

Capacitance	Temperature	Others
Single floating capacitors 1 sensor, 1 reference, fully compensated Rdisch = 90 kOhm, 20 μ s cycle time 12.2 Hz data rate Averaging 100 samples	Internal sensor and reference C-measurement triggered 12.2 Hz 140 μ s cycle time	Sequence time triggered

The configuration in detail is the following:

```

Register 0:      'h 42 00 FF
Register 1:      'h 20 10 22
Register 2:      'h 0F 45 0B
Register 3:      'h 0B 00 64
Register 4:      'h 08 00 01
Register 5:      'h 00 00 00
Register 6:      'h 00 43 40
Register 7:      'h 1F 00 00
Register 8:      'h 80 00 30
Register 9:      'h FF 00 0F
Register 10:     'h 18 00 87
  
```

Steps 1. to 3. equal those in the first example.

4. Wait 100ms, then read the status register (address 8) and results Res0, Res1 and Res11 (addresses 0, 1 and 14). For reading 24-bit status and results use the following 32-bit format:

```
{2'b01, 5'b<Result_Address>, 23'b<Result_Data>}
```

It is expected to find status=`'h100000` or `0x900000`.

Res0 could be e.g. in the range of 70000. This integer value, multiplied by typ. 21ps resolution gives an indication of the discharge time measured. With 70000 we would have a discharge time of 1.5 µs. Of course, this value depends on the capacitors used.

Res1 is expected to be in the range of 2,000,000 or ,h1FF2XX if the two capacitors are of same size. Res0 has the format of a fixed point number with 3 integer digits and 21 fractional digits. So , dividing the 2,000,000 by 2^21 gives a factor of about 1 for the ratio C1/CO.

Res11 gives the ratio of R(alu)/R(Si-poly) and should be something like 1,750,000. Converted into the fractional number (division by 2^21) this is about 0.84, a typical ratio at room temperature.

6.5.4 Configuration, Example 3

This example refers to a capacitance measurement at 1 kHz. with 2 Hz temperature measurement (ext. sensor)

This example features:

Capacitance	Temperature	Others
Single grounded capacitors 1 sensor, 1 reference, internally compensated Rdisch = 30 kOhm, 20 µs cycle time 1.04 kHz data rate Averaging 16 samples	CMEAS triggered External PT1000 at port PTO vs. internal Poly-Si reference 2.06 Hz data rate 280 µs cycle time	Continuous mode

The configuration in detail is the following:

```
Register 0:      'h 42 00 FF
Register 1:      'h 20 10 22
Register 2:      'h 03 16 0B
Register 3:      'h 06 00 10
Register 4:      'h 04 01 11
Register 5:      'h 00 01 F8
Register 6:      'h 00 49 40
Register 7:      'h 1F 00 00
Register 8:      'h 80 00 04
Register 9:      'h BB 00 00
Register 10:     'h 18 00 40
```

Steps 1. to 3. equal those in the first example.

4. Wait 100ms, then read the status register (address 8) and result Res1 from address 1. For reading 24-bit status and result use the following 32-bit format:

```
{2'b01, 5'b<Result_Address>, 23'b<Result_Data>}
```

It is expected to find status=`'h100000` or `Ox900000`.

Res1 is expected to be in the range of 2,000,000 or ,h1FF2XX if the two capacitors are of same size. Res0 has the format of a fixed point number with 3 integer digits and 21 fractional digits. So , dividing the 2,000,000 by 2^{21} gives a factor of about 1 for the ratio $C1/C0$.

Res11 gives the ratio of $R\{PT1000\}/R\{Si-poly\}$ and should be something like 2,080,000. Converted into the fractional number (division by 2^{21}) this is about 0.994, a typical ratio at room temperature.

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7 Miscellaneous

7.1 Bug Report

7.1.1 I2C Bug

Description

In case PCap01A is not the only device on the I2C bus we have the following errors, show intable 7-1:

Table 7-1 : Communication between Master and some Slave other than PCap01

Situation	Expected behavior	Actual behavior	Conclusion
Master initializes communication with another slave than PCap01	PCap01 should remain silent like it were absent from the bus.	PCap01 acknowledges any address byte. It sets the ACK bit like if it had been called with its own address [1][2]	wrong
Master has established communication with another slave and is writing data to, or reading data from it.	PCap01 should remain neatly off the SDA line.	PCap01 acknowledges any data byte in parallel to slave's[2] and master's[3] ACK or despite their respective NACK	wrong
	PCap01 should ignore the data bits themselves	PCap01 does not listen to those data bits that are sent to others.	right

[1] If the requested slave is present and ready to respond, this will be tolerable.

[2] NACK (refused acknowledge) no longer exists in this kind of a situation.

[3] This kind of „meddling with the master’s business“ may trouble the master (caution with integrated i2C controllers). Master is requested not to leave its master status and to issue a STOP condition.

Preliminary suggestions

- Take the SPI interface, if possible. No problem detected on SPI.
- If you need the I2C interface, restructure your network so that PCap01 is connected single-slave to the master.
- If you need I2C and cannot avoid a multi-slave bus structure, be aware of the restrictions to the bus protocol, described in this report

Consequences on integrated I2C controllers (with more than one slave)

The use of hardwired I2C interfaces with multi-master capability may cause error during read operations, because a master may go to Error due to some ACK bit arriving within a „read“ process (as the master alone should acknowledge data from slaves). This may completely block the interface, unless the master has been instructed not to listen to the line for detecting possible master-collision situations¹.

As write operations are possible, I2C expanders can be used to interface PCap01 in multi-slave systems.

¹ In multi-master systems, two members may incidentally become master at a time. This is part of the standard, in no ways problematic and remains unnoticed by the slaves. Both co-masters listen to the SDA line each time they write a ‚high‘, so as to detect possible ‚lows‘ written by a co-master. Whenever this situation arises, any ‚high‘ emitting master immediately becomes slave and lets the other master(s) be master alone. PCap01 creates confusion with respect to this. The master writing NACK (‚high‘) sees ‚low‘ from PCap01’s ACK. It believes that PCap01 is co-master (which it is not) and returns to slave. PCap01 waits for the next clock pulse to come, but none arrives. Consequence: there is no more master on the bus; the bus hangs in an occupied state and with permanent SDA=‘low’ (ACK from Pcap01) and SCL=‘high‘.

Consequences on hand-written, „software“ I2C interfaces

You are recommended to simplify and to modify the interface protocol :

- The most basic subset of the I2C standard will be best.
- Multi-master, arbitration and the like should be skipped.
- Master must ignore any ACK bits set in competition with its own ACKs or NACKs.
- Master cannot rely on any ACK bits issued by other slaves than PCap01. ACK bits are likely to come from PCap01. Pay attention to this, especially during debugging and for error-handling.
- Some work-around may be necessary in order to check for the presence and readiness of a slave, which standardwise would be signaled through an ACK.
- You cannot use NACK bits. In particular, NACK cannot be used to signal „end of transfer“ to a slave. You must abort by a repeated start or by a stop condition.
- If possible use an I2C expander in multi-slave applications.

7.1.2 SPI Limitation

In some applications, several components are wired to the same SPI bus and are individually addressed through the chip-select (SSN) line. For this to work, any non-addressed component, seeing SSN ‚high‘, must set its MISO port to high impedance.

No high-impedance state existing on MISO port inside PCap01.

Workaround: Avoid bus sharing, or insert an (inexpensive) external single-gate tri-state buffer between PCap’s MISO port and the MISO line.

7.1.3 Power-up Reset Limitation

In case of shorttime power down the PCap01 does not safely detect the power-down. In consequence, it may happen that the chip does not run a power-up procedure but hangs up.

Workaround: In stand-alone operation the PCap01A needs an additional external power-up circuit. In frontend operation the PCap01A needs a dedicated software power-up reset by the microcontroller.

7.2 Document History

04.08.2010	First release
03.09.2010	Complete revision, release 0.2, re-layout
28.04.2011	Complete revision, release 0.3, based on standard firmware version 03.01
13.05.2011	Fig. 4-3 plus minor corrections



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